

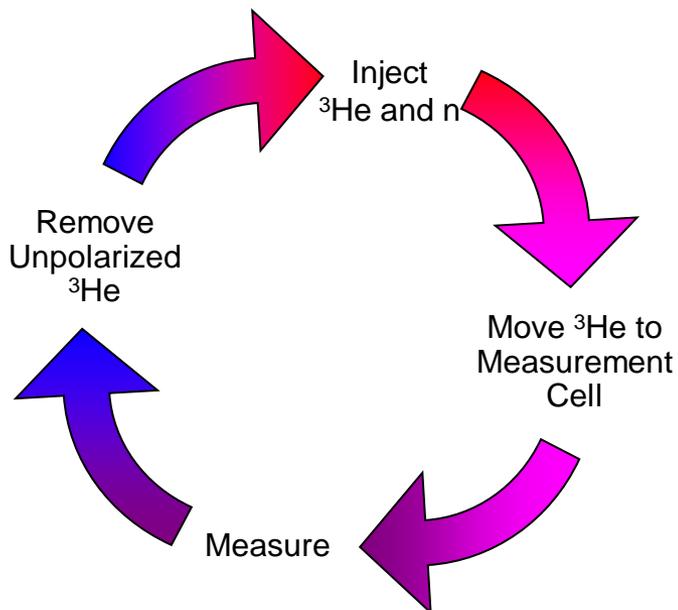
^3He Polarization & Transport

Steven Williamson

- Overview of the ^3He Services for nEDM@SNS
- Challenges for ^3He Services
- R&D Example: Superfluid helium film control

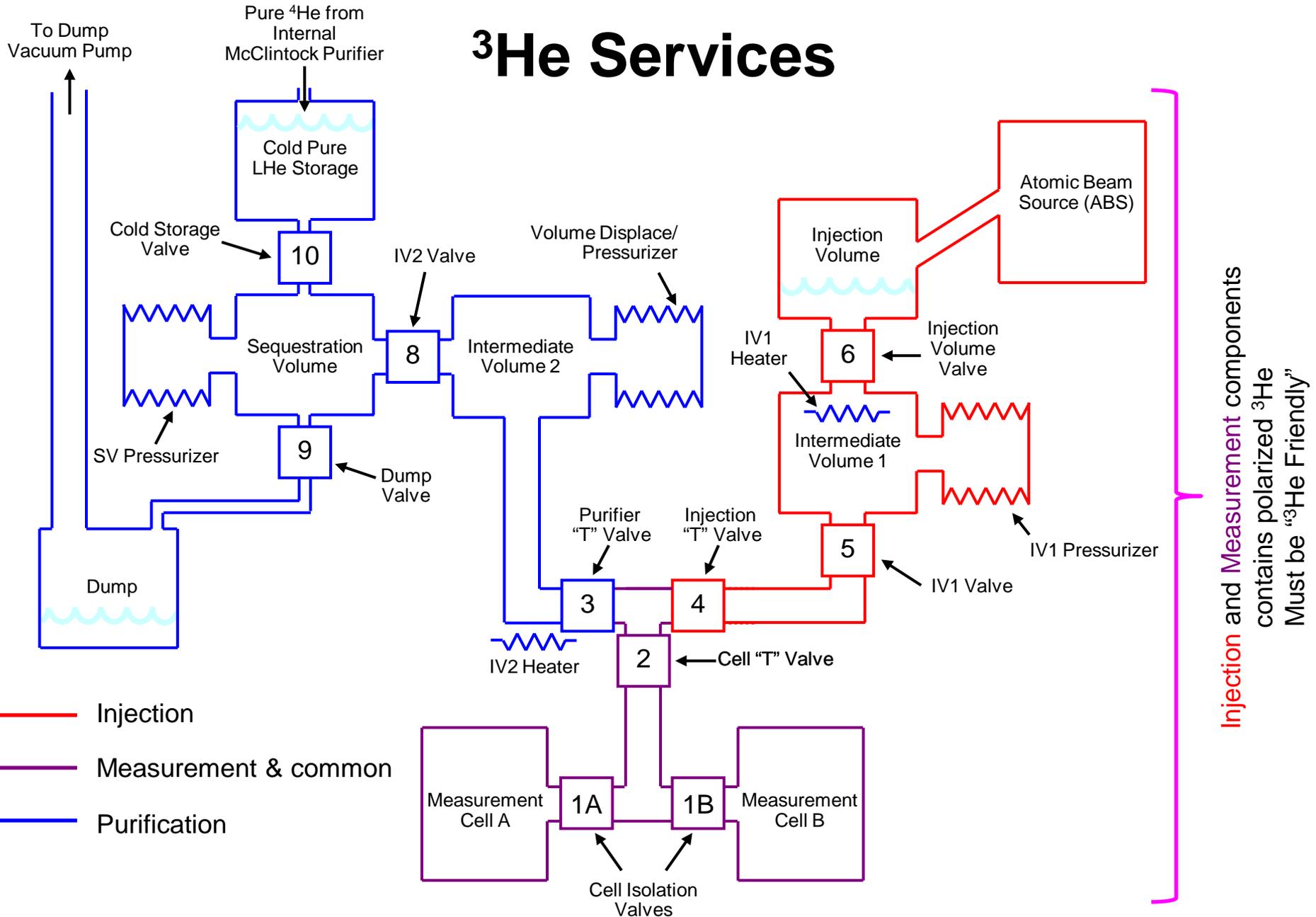
Polarized ^3He in nEDM@SNS

- Polarized ^3He provides:
 - Comagnetometer measure of B field seen by neutrons
 - Mechanism for detecting neutron spin precession
- The experiment relies on efficient...
 - **injection** of polarized ^3He into isotopically purified ^4He
 - **transport** of the polarized ^3He to the measurement volumes
 - **maintenance** of polarization during the measurement
 - **removal** of unpolarized ^3He when a precession measurement is complete.



Time	Neutrons	^3He
Measurement complete		
200 s		Remove from cell to holding volume 2
100 s		Move to cell
700 s	Accumulate in cell	Move to dump
700 s	Measure	Inject ^3He into He II
		Move to holding volume 1

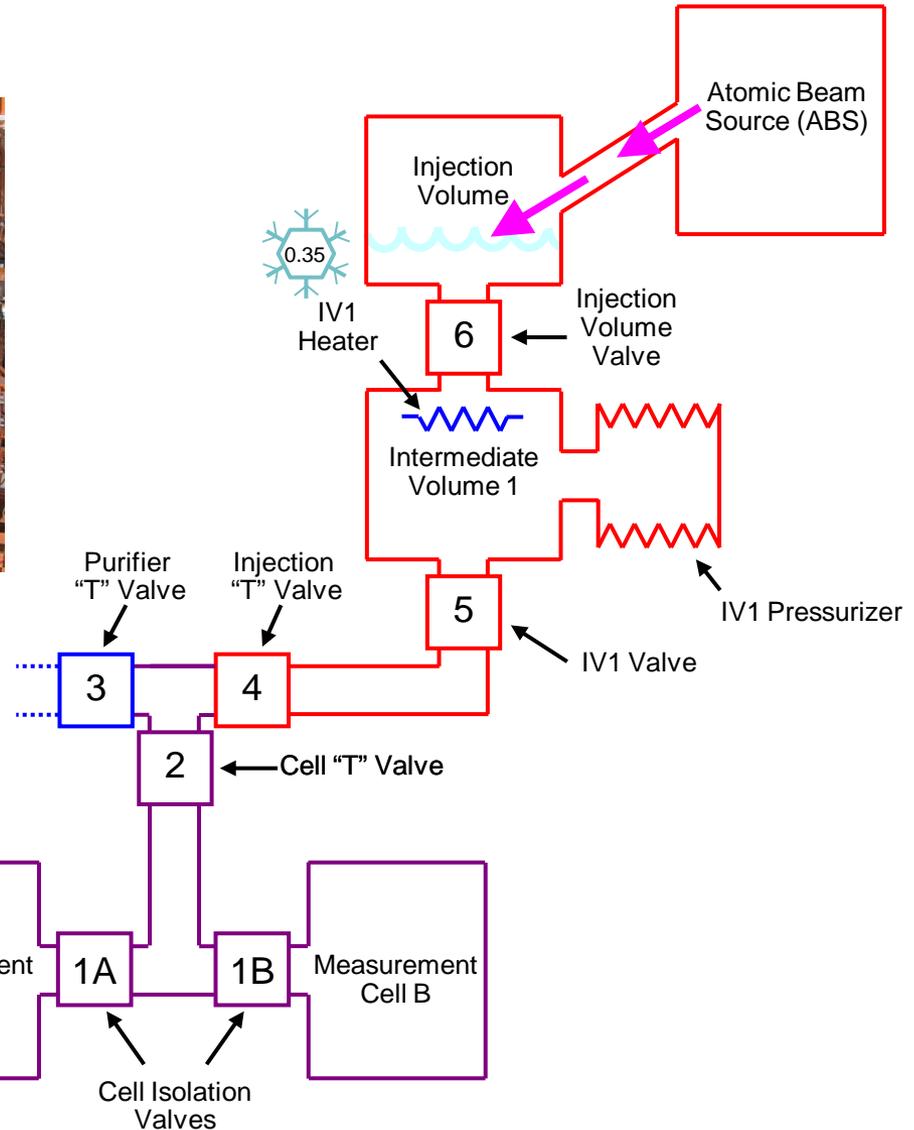
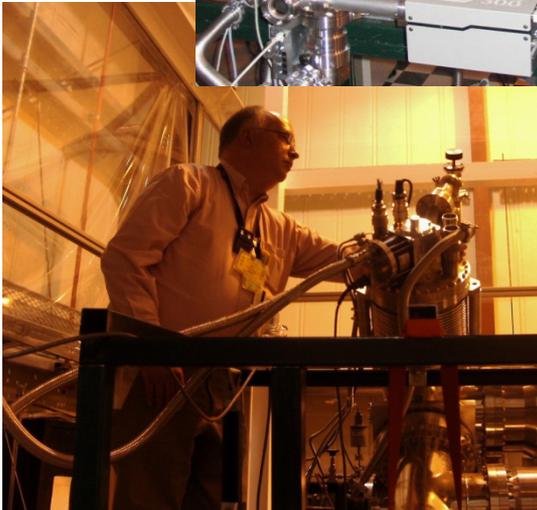
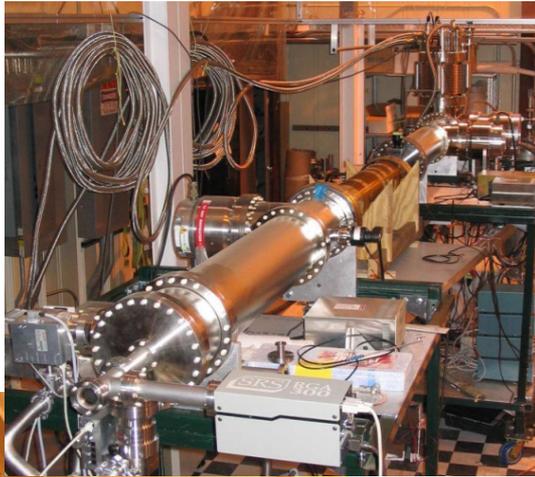
^3He Services



- Step 1: Inject Polarized ^3He from ABS

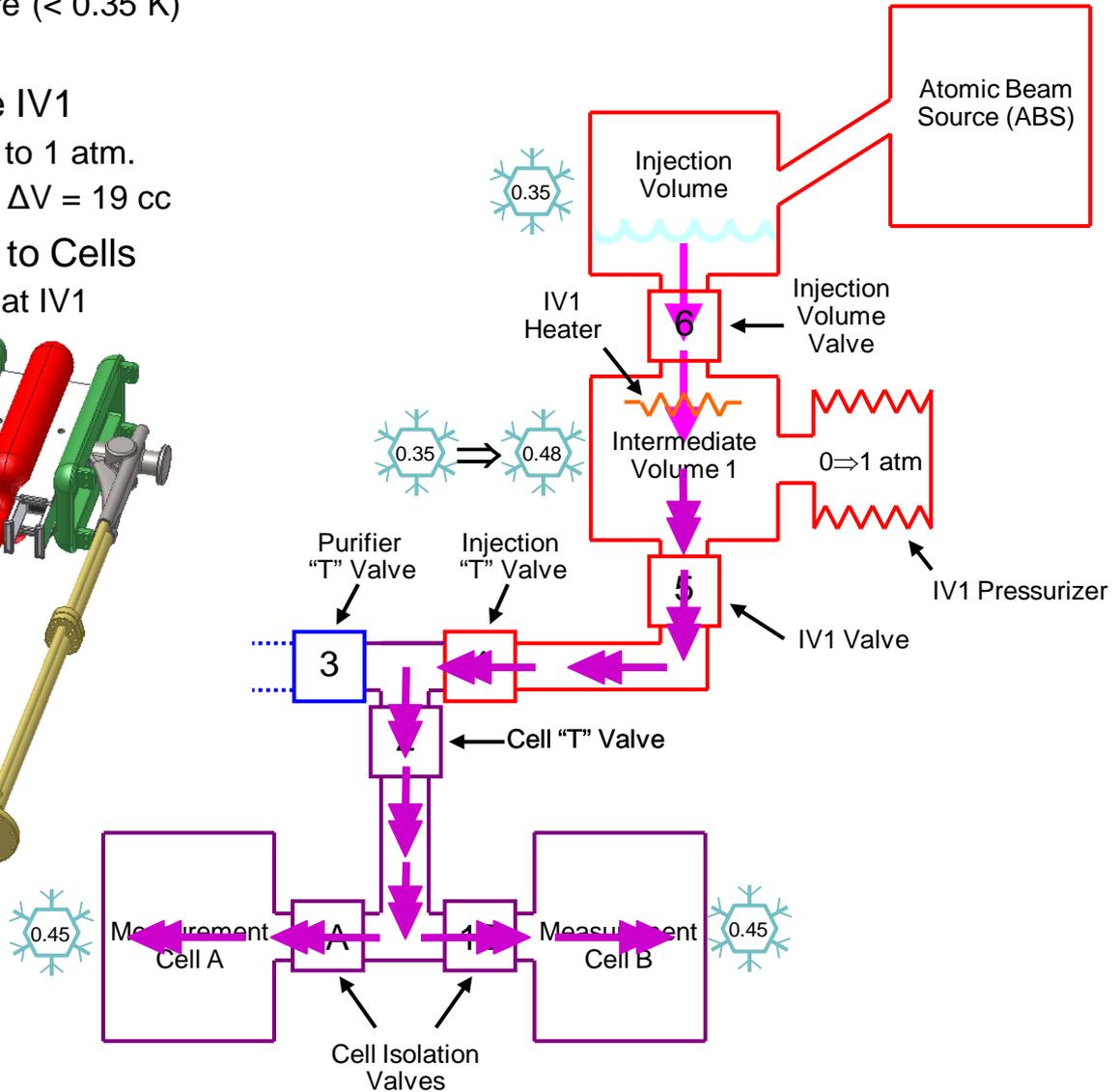
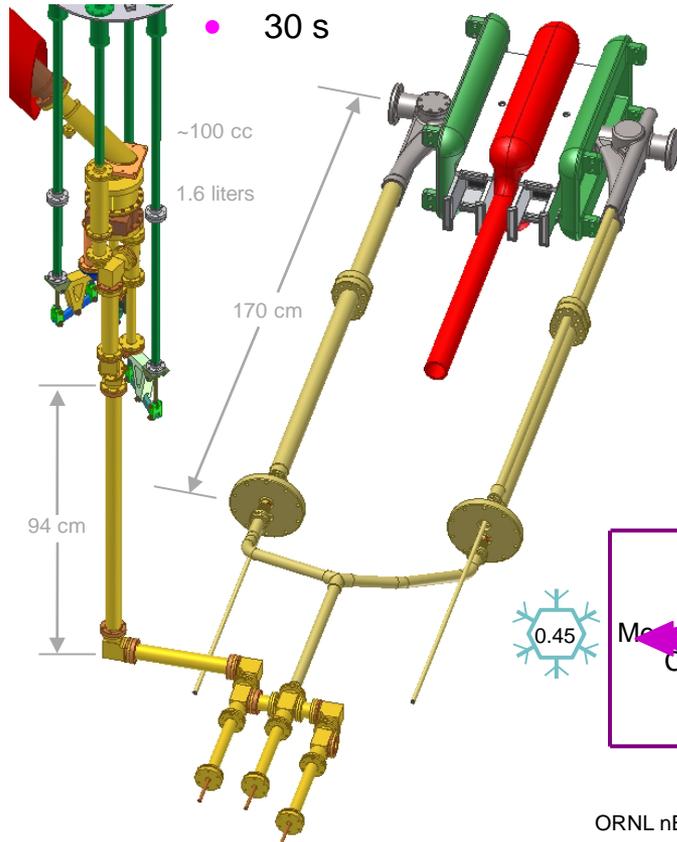
- Existing Equipment
- 2×10^{14} atoms per sec
- 99.6% Polarization
- 30 s

Injection

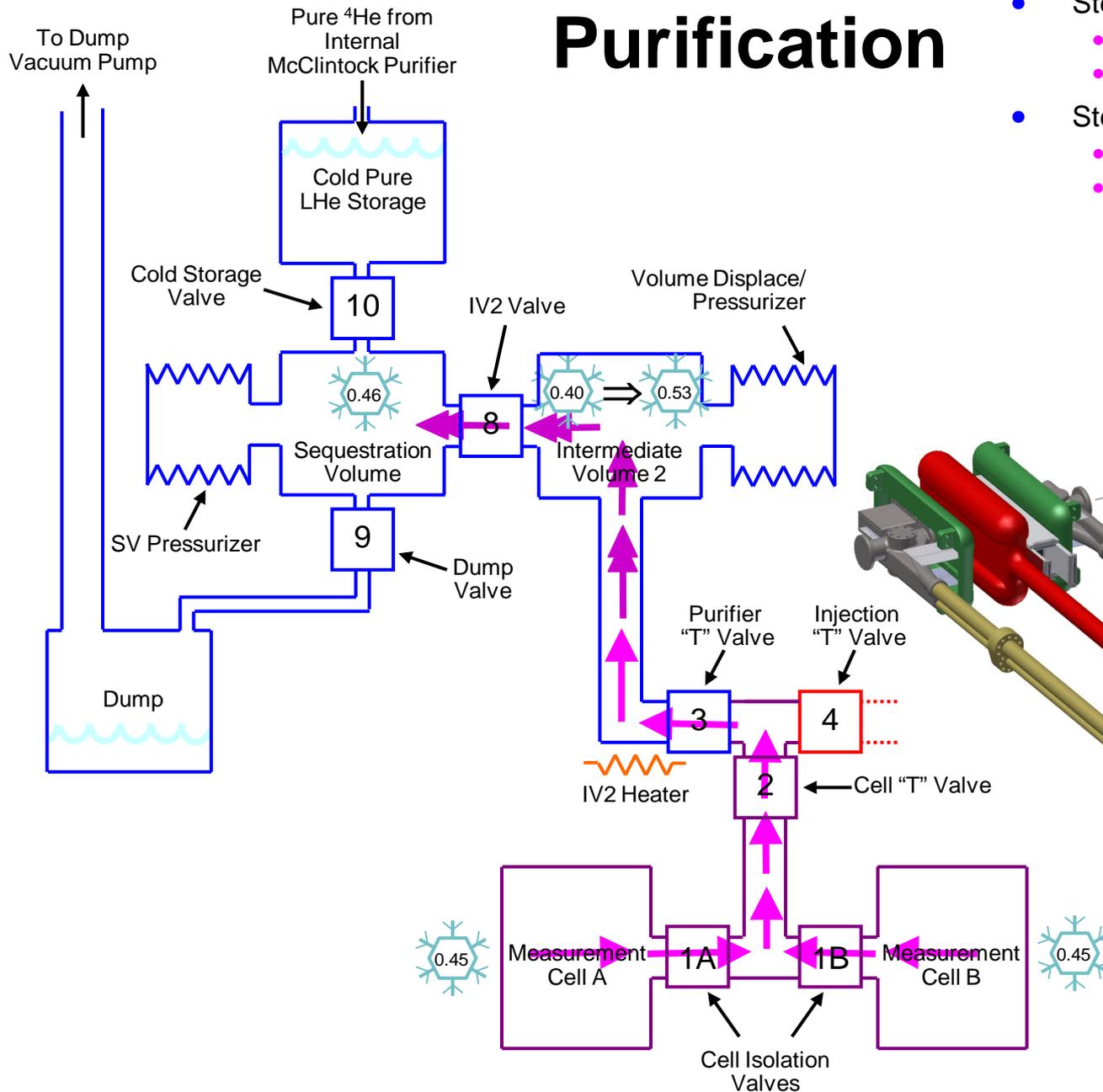


- Step 1: Inject Polarized ^3He from ABS
- Step 2: ^3He Diffuses to IV1
 - Low (~zero) pressure
 - Low temperature (< 0.35 K)
 - 2 sec
- Step 3: Pressurize IV1
 - Raise pressure to 1 atm.
 - $\Delta V / V = 1.19\%$, $\Delta V = 19$ cc
- Step 4: Heat flush to Cells
 - 5 mW supplied at IV1
 - 30 s

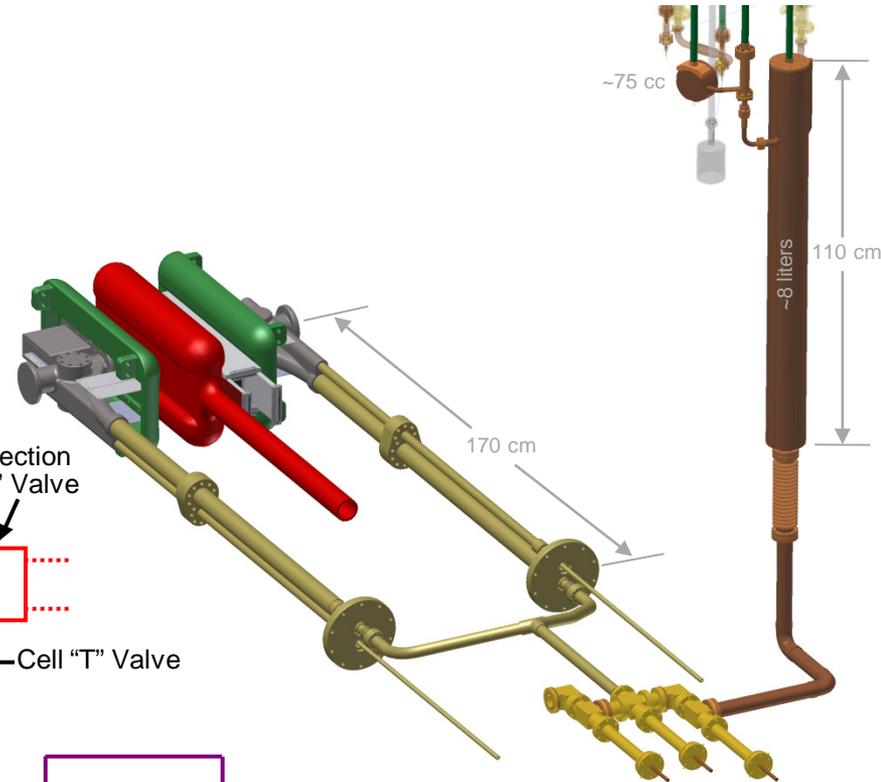
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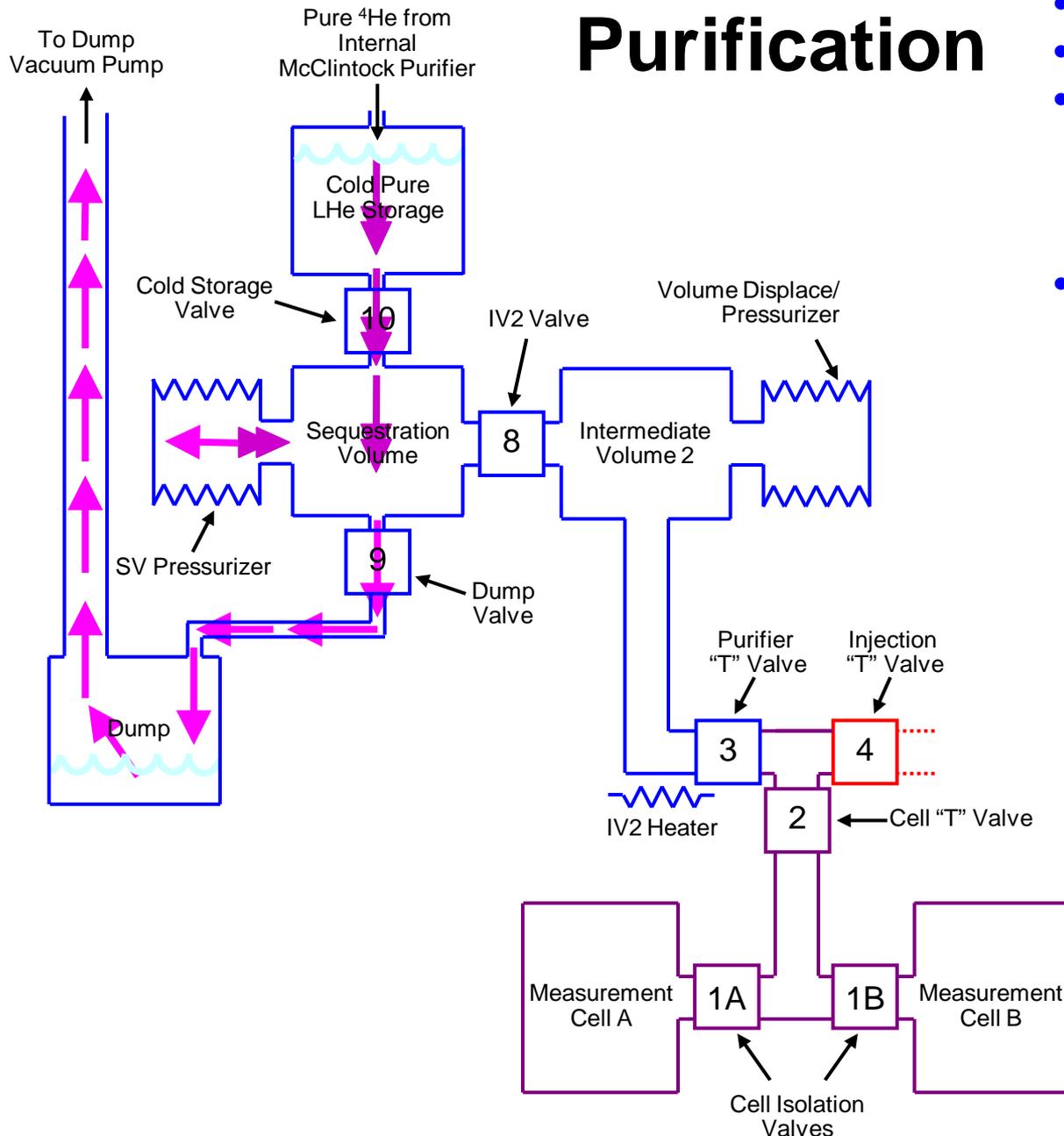
Purification



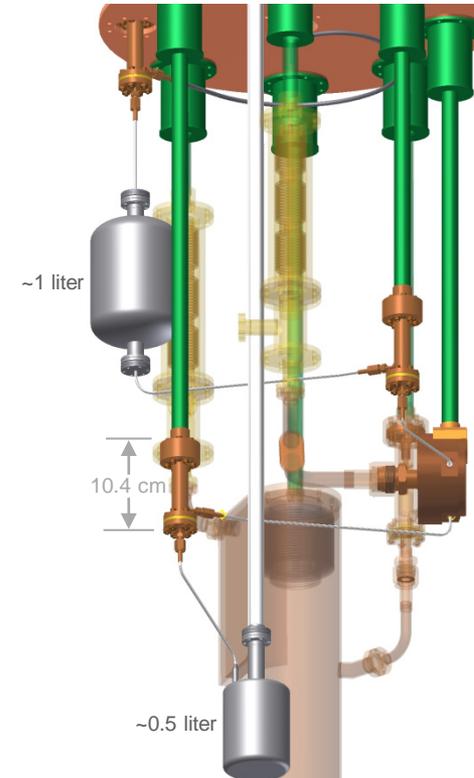
- Step 1: Flush from cells to IV2
 - 5 mW extracted at IV2
 - 350 s
- Step 2: Heat flush from IV2 to SV
 - 8 mW extracted at SV
 - 150 s



Purification



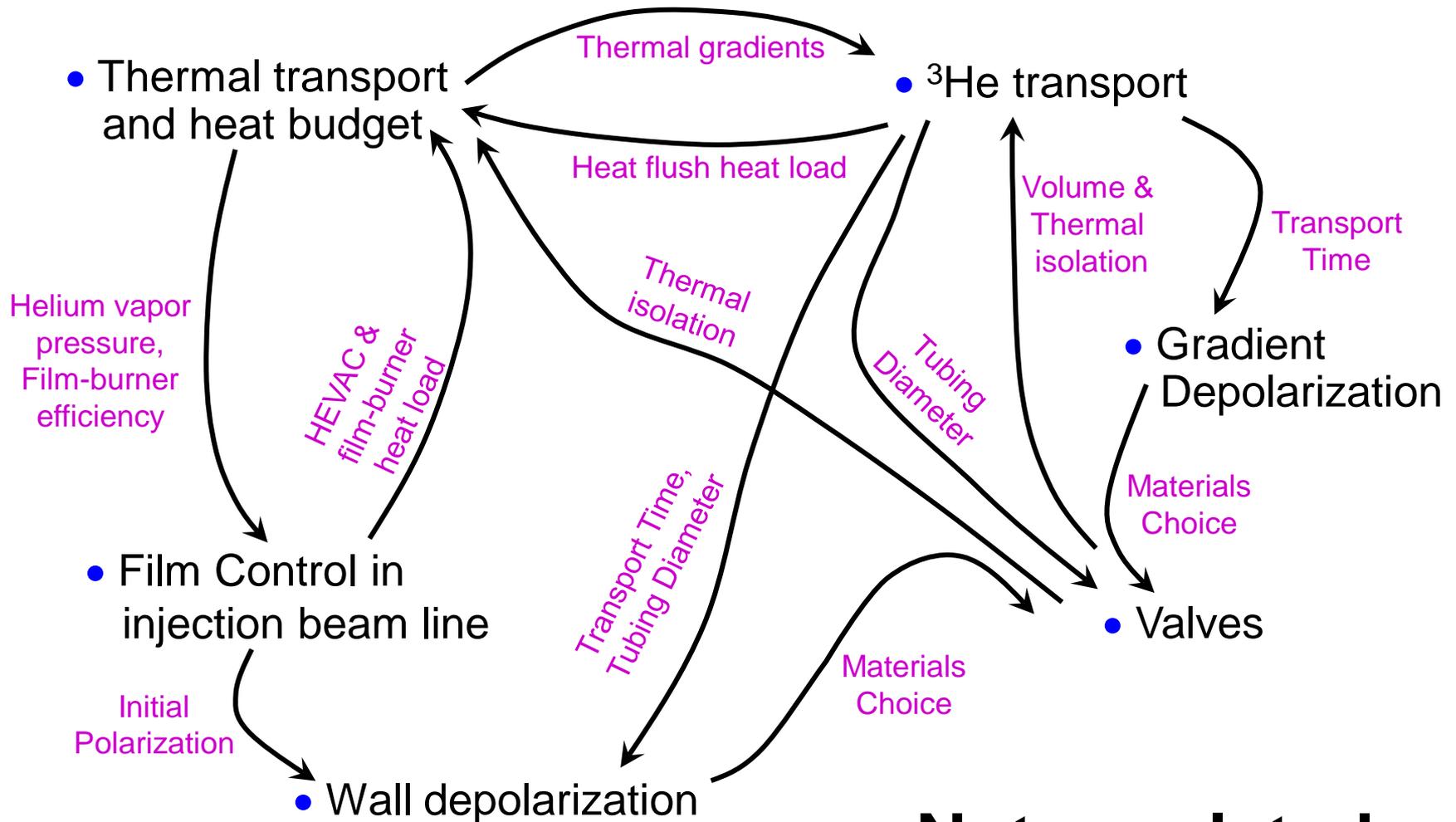
- Step 1: Flush from cells to IV2
- Step 2: Heat flush from IV2 to SV
- Step 3: Dump the SV
 - Depressurize the SV first
 - Evaporate and pump away depolarized ^3He
 - 85 s
- Step 4: Replace ^4He
 - Pure ^4He from internal McClintock Purifier
 - Pure storage provides reservoir
 - Re-pressurize SV after filling
 - 60 s



Challenges for ^3He Services

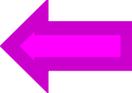
- Heat Budget
 - Thermal isolation (e.g. of valves)
 - Adjustable thermal links
- Valves
 - Superfluid tight
 - Large diameter
 - ^3He friendly
 - etc.
- Depolarization
 - Wall depolarization
 - Gradient Depolarization
- ^3He Transport
 - Diffusion at $T \leq 300$ mK
 - Heat flush for $T \geq 400$ mK
- Thermal contraction of long plumbing runs
- Many joints and flange-seals
- Film control in the injection beam line

Challenges for ^3He Services

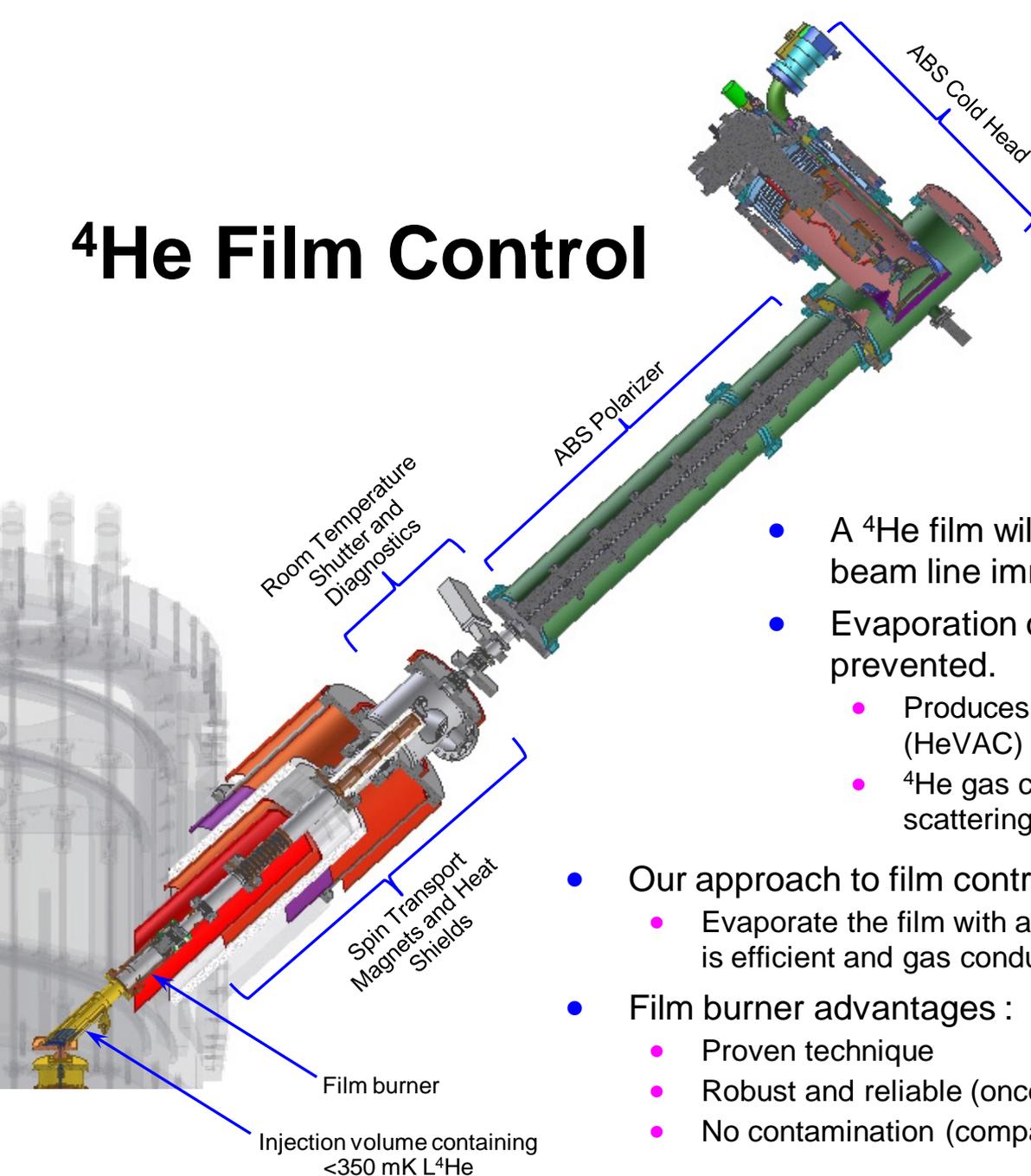


... Not unrelated

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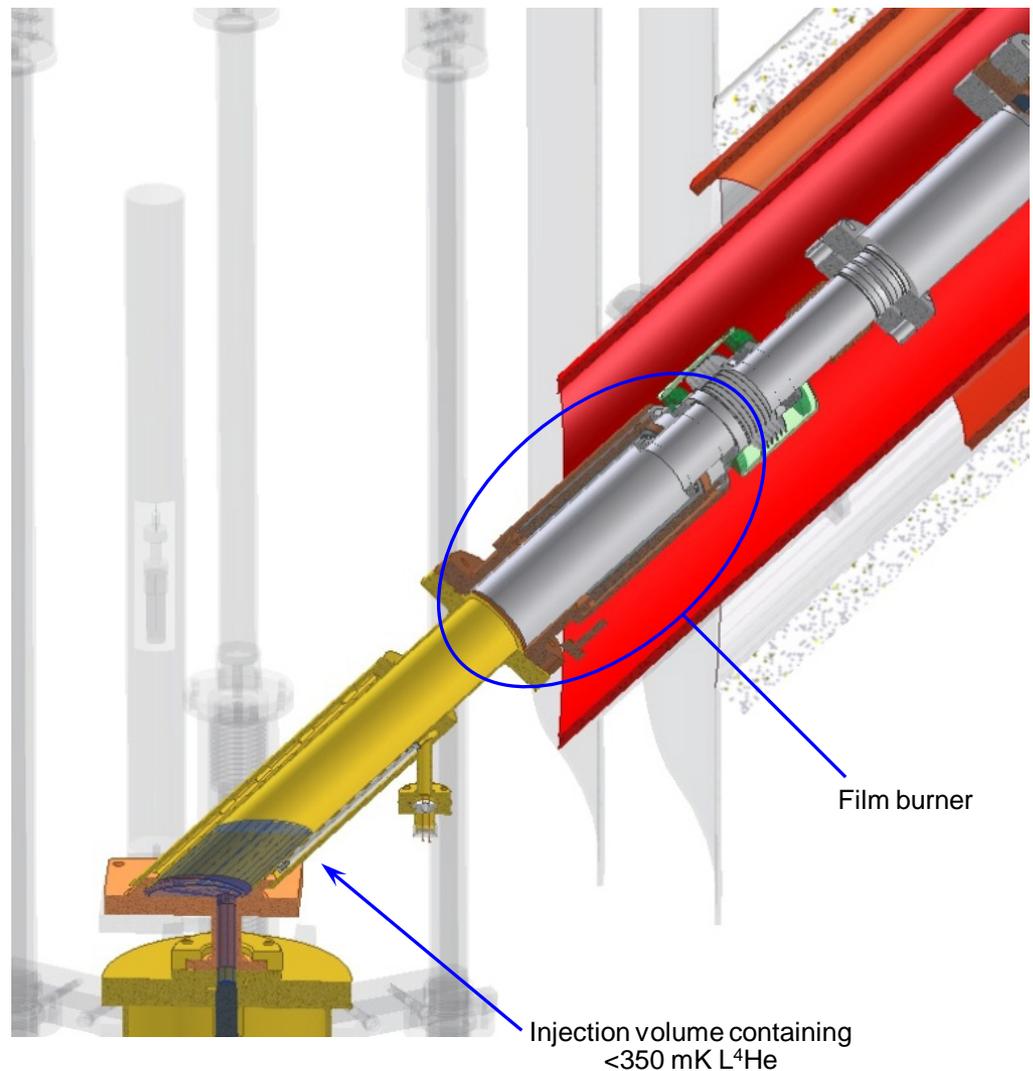
^4He Film Control



- A ^4He film will be generated on the walls of the beam line immediately above the bulk LHe.
- Evaporation of film into beam line must be prevented.
 - Produces large heat load to injection volume (HeVAC)
 - ^4He gas can block the beam (^3He - ^4He atomic scattering)
- Our approach to film control: a “Film Burner”
 - Evaporate the film with a heater. Then re-condense it where cooling is efficient and gas conductance to beam line is low.
- Film burner advantages :
 - Proven technique
 - Robust and reliable (once it works).
 - No contamination (compared to Cs ring).

Film Control

- Film burner challenges:
 - Efficient cooling is required to remove the heat supplied by the evaporator.
 - The conductance of vapor from evaporated film to the beam line must be small.
 - Operation depends on the details of
 - The heat load
 - The condenser cooling
 - The geometry of the evaporator/condenser



- Difficult to model \Rightarrow a test is needed to prove a given design.

Film Burner Design

Heater Power Estimate

$$v_f \cdot t_f = 1.2 \times 10^{-4} \text{ cm}^2 / \text{s}$$

t_f = film thickness (depends on surface)
 $\cong 30 \cdot h^{-1/3} \text{ nm}$ (with h in cm) (10-12 nm)

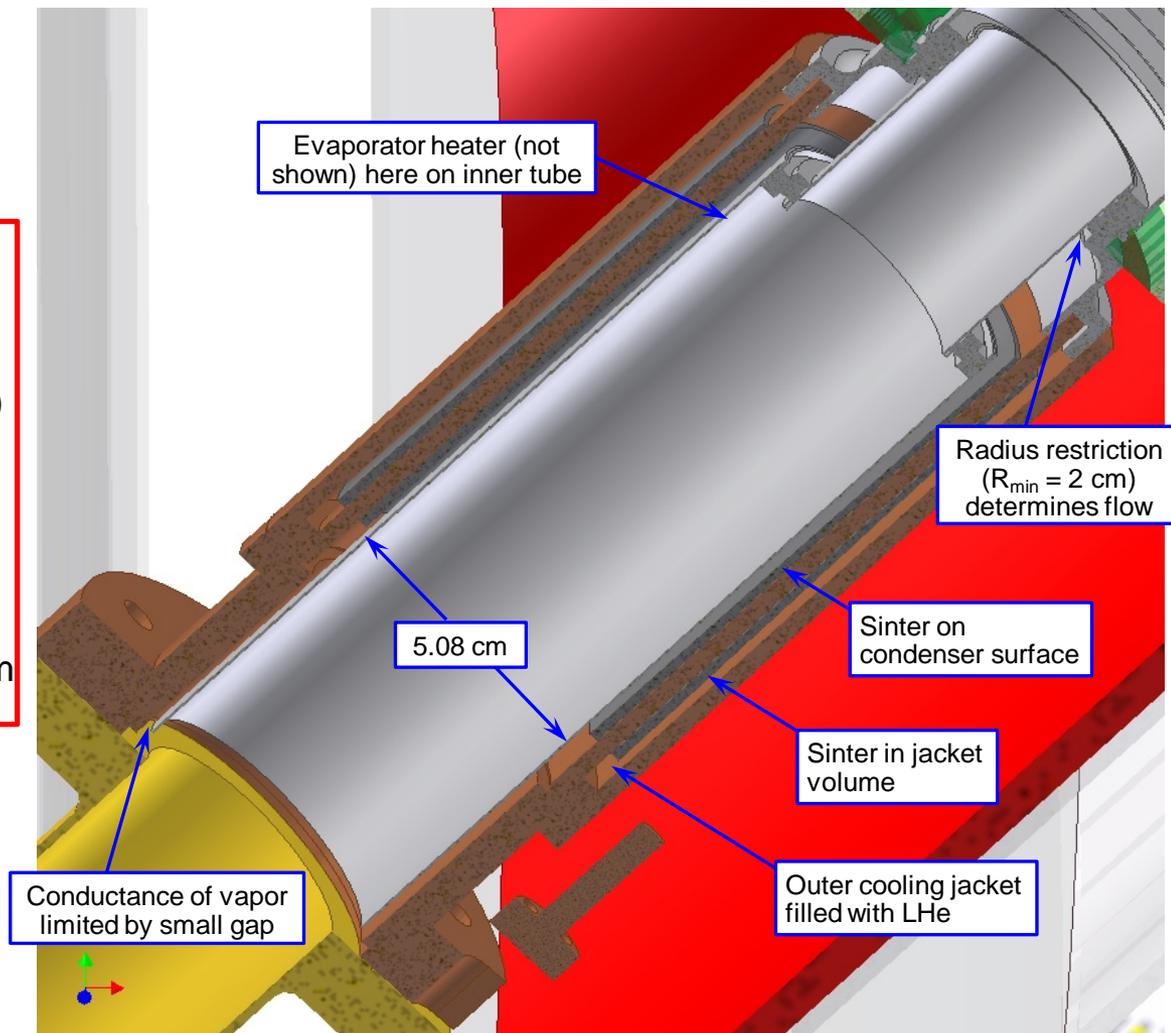
v_f = film velocity (of order 50 cm/s)

$$P = v_f \cdot t_f \cdot 2\pi R_{\min} \cdot L \cong 4.5 \text{ mW}$$

L = heat of vaporization = 3.02 J/cm³

R_{\min} = minimum (upward) radius = 2.0 cm

- Typical temperature required to vaporize film is 0.7 to 1 K
- To insure full condensation, condenser surface should be at < 0.35 K
- Cooling supplied to outer jacket of condenser by DR Mixer via LHe thermal link
- To overcome Kapitza resistance, sinter is needed on both inner and outer surface of condenser.
- Limiting radius defined at top of film-burner where beam is smallest.



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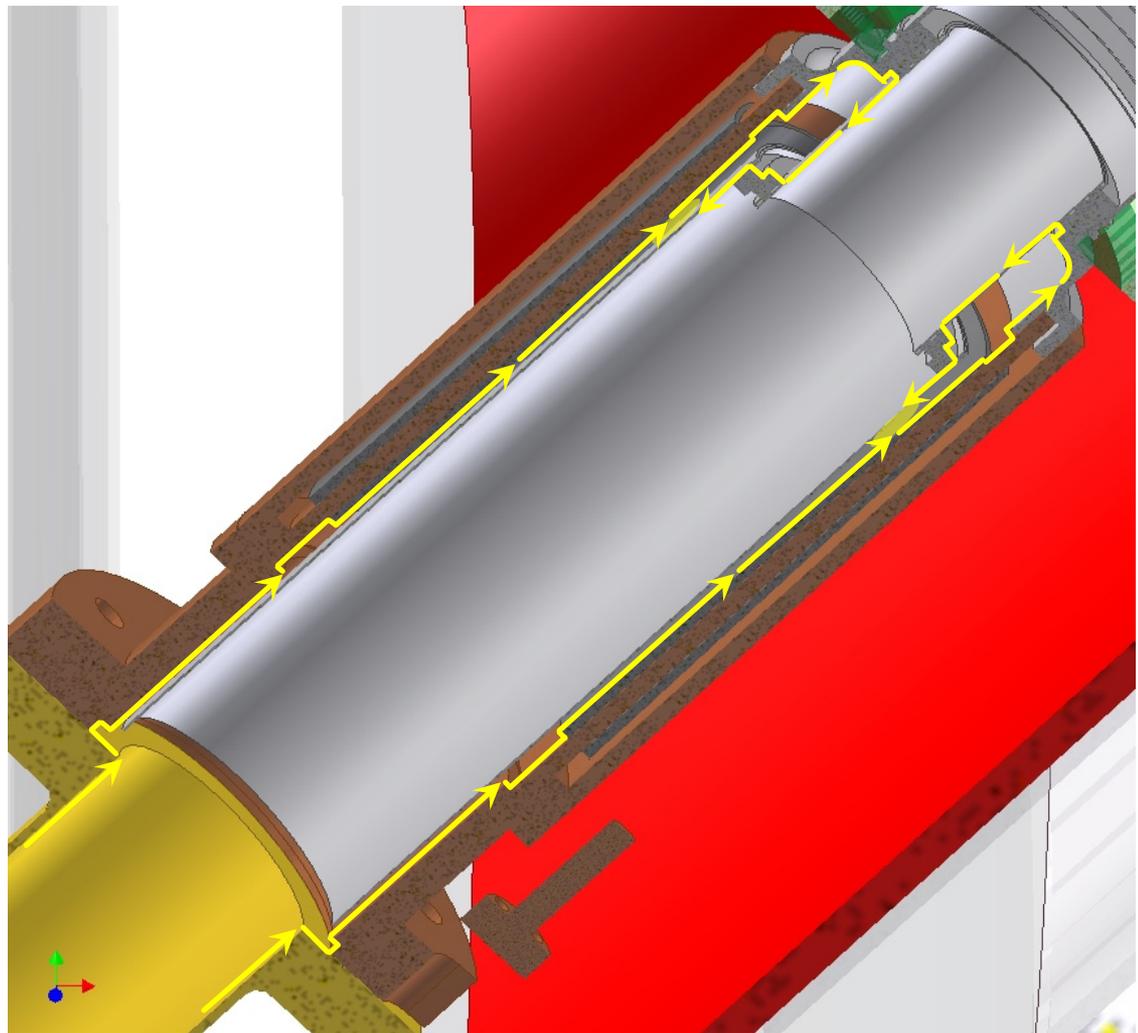
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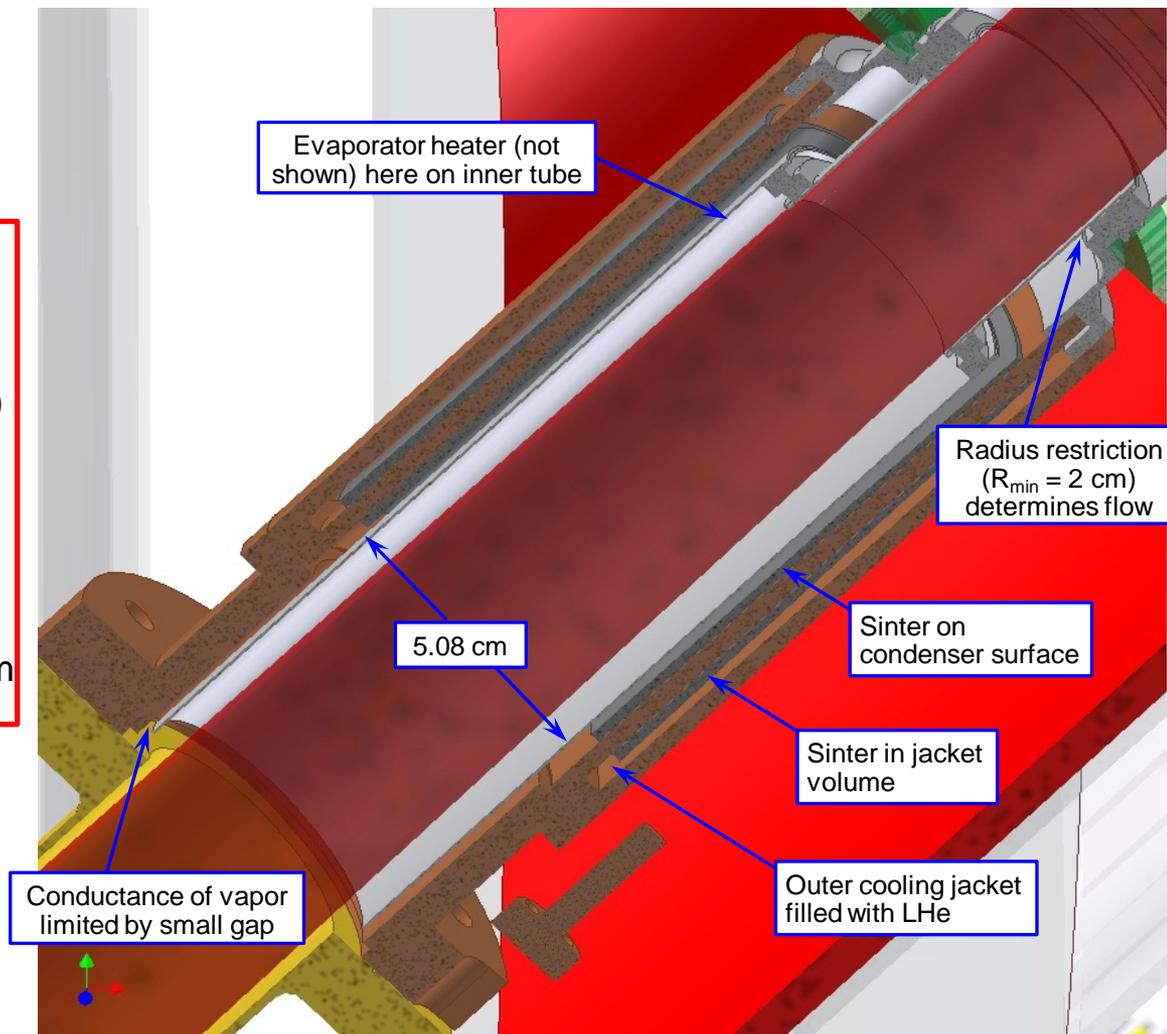
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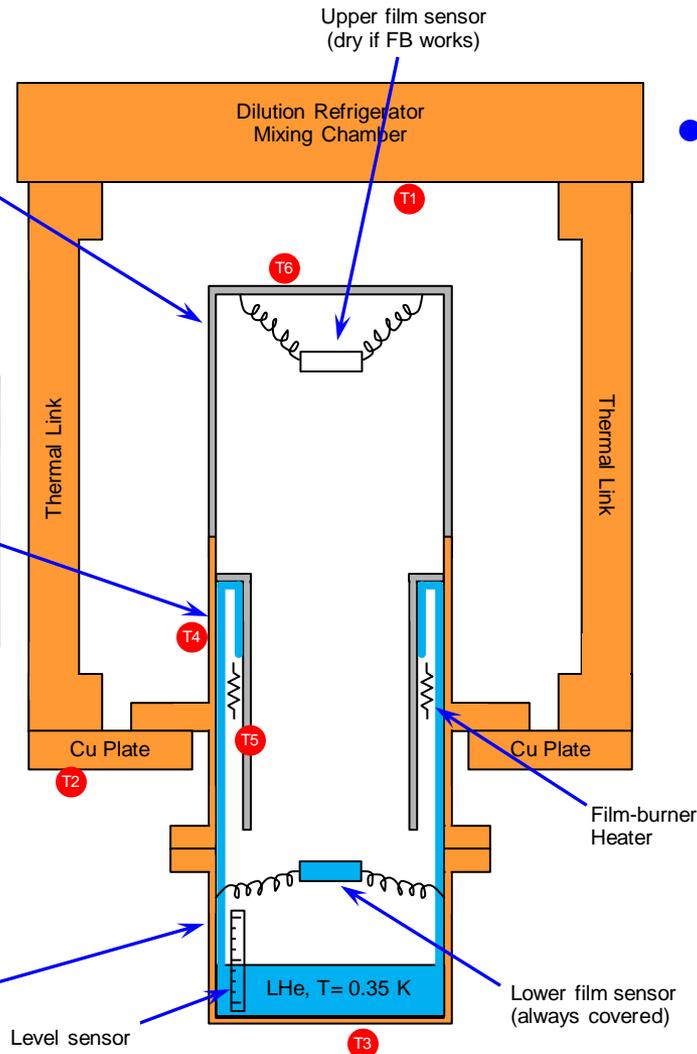
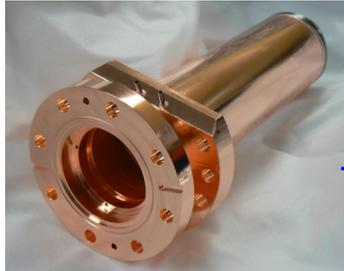
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- To overcome Kapitza resistance, sinter is needed on both inner and outer surface of condenser.
- Limiting radius defined at top of film-burner where beam is smallest.
- Diameter is determined by the projected size of the collimated beam

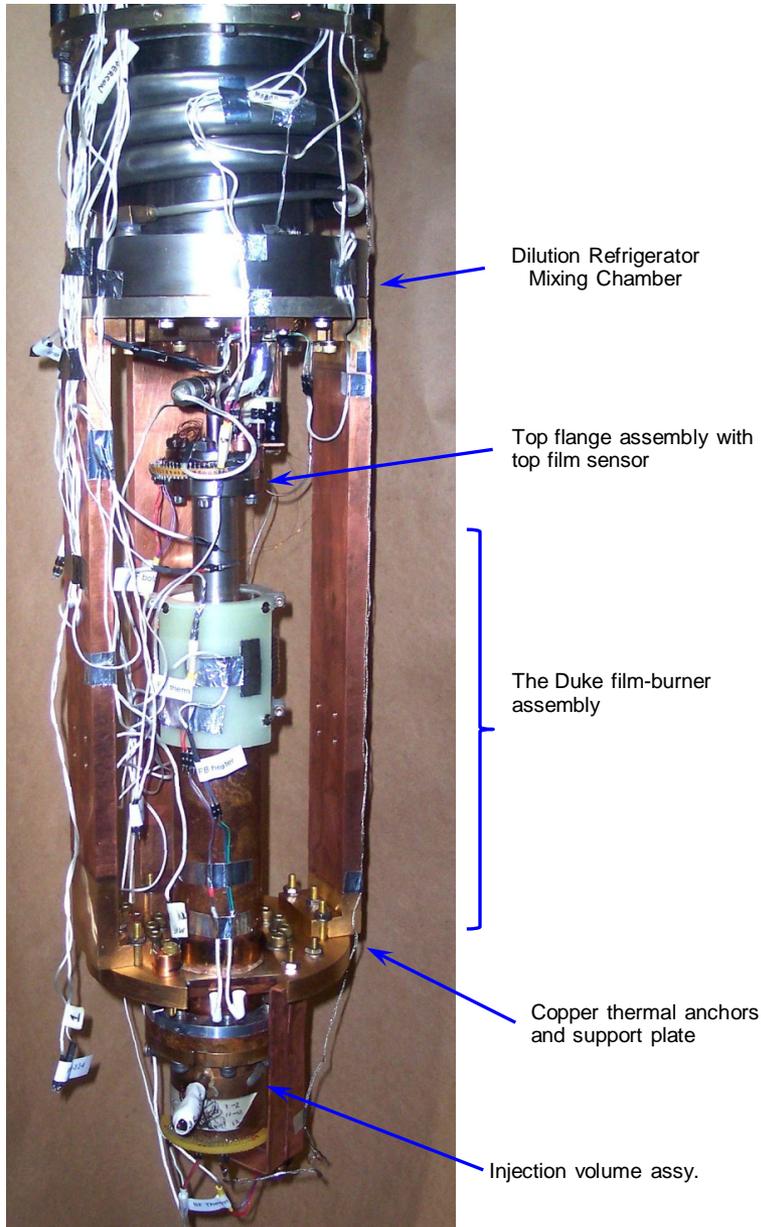


A “Simple” Test of the Film-burner



- Initial test plan (a.k.a. Phase 1):
 - Using DR in Ike Silvera’s Harvard lab (~ 8 mW @ 300 mK)
 - Use existing (but untested) Duke film-burner
 - Cooled with copper thermal links
 - $R_{\min} = 1.33$ cm (2/3 of real FB)
 - $P = 3$ mW
 - Success: elimination of film above film-burner.

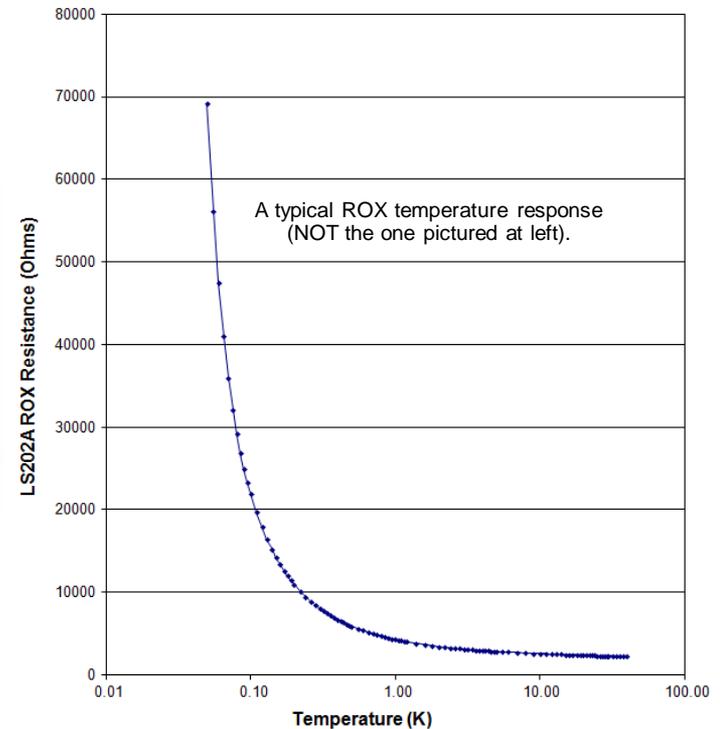
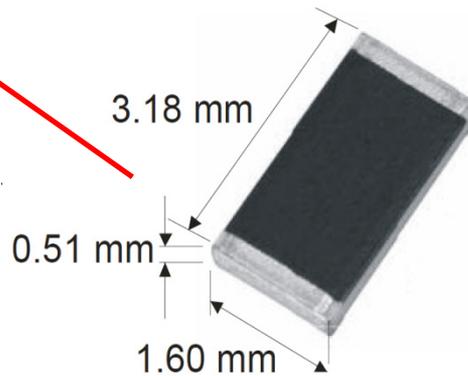
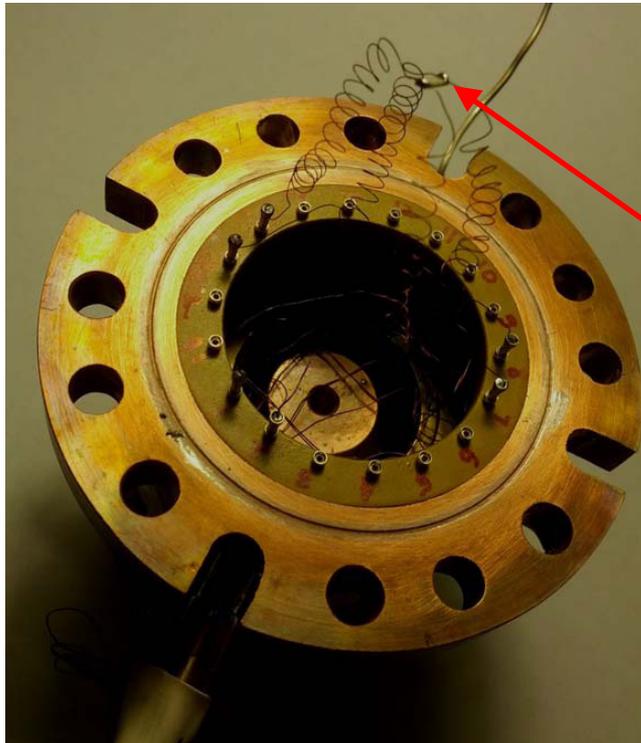
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- Progress so far...
 - Commissioning of the DR 1/12 to 3/12
 - Test cool-downs, 6/12 and 8/12
 - Successful test run, 9/12

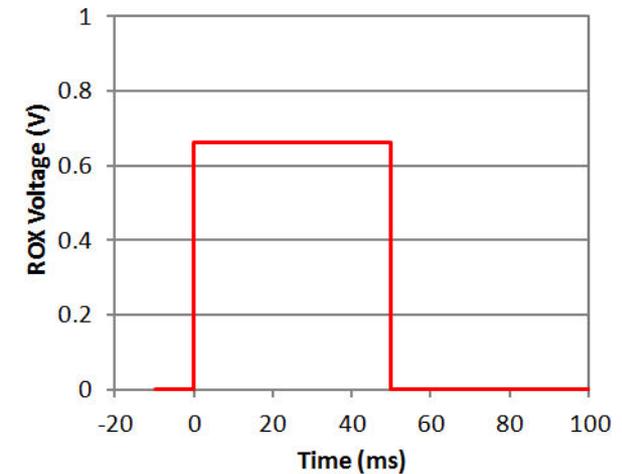
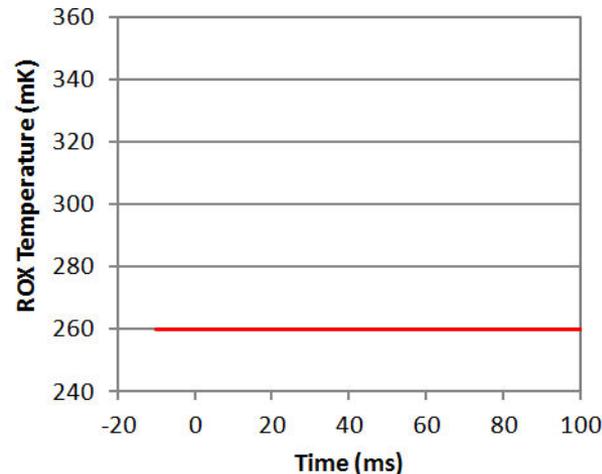
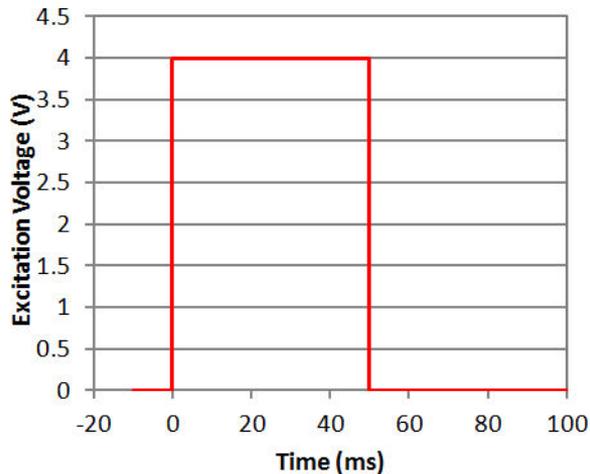
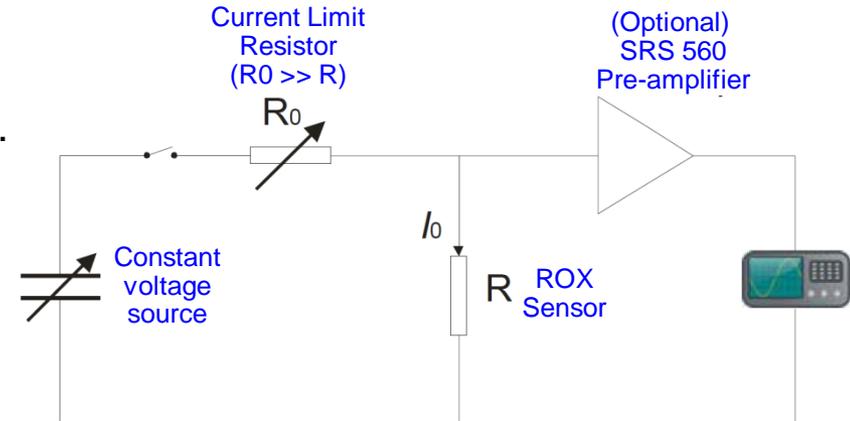
Helium Film Sensor

- Use a surface-mount RuO₂ resistor as uncalibrated temperature sensor.
 - 10 k Ω at room temperature
 - > 100 k Ω below 50 mK
 - < 1 cent each (we bought 6000!)
- Suspend from fine wires to thermally isolate sensor.
- Two film sensors:
 - On inj. vol. – always covered with film (when LHe is present)
 - On top flange assembly – should not be covered if film burner is working.



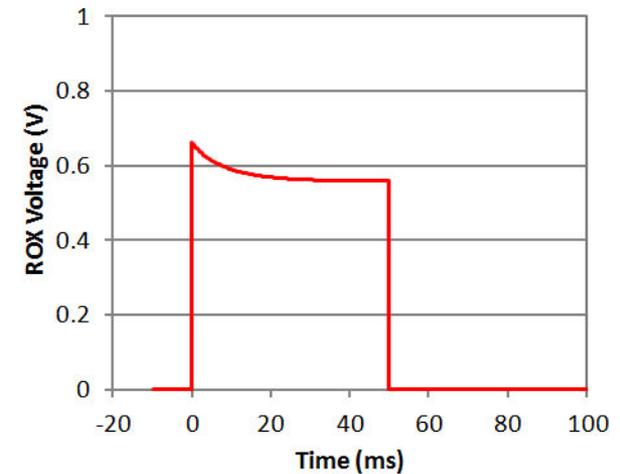
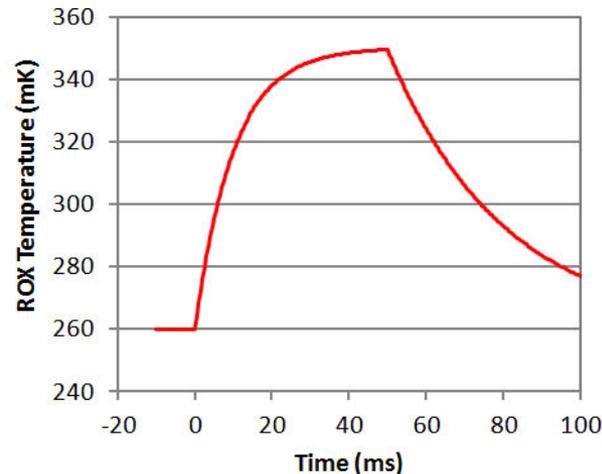
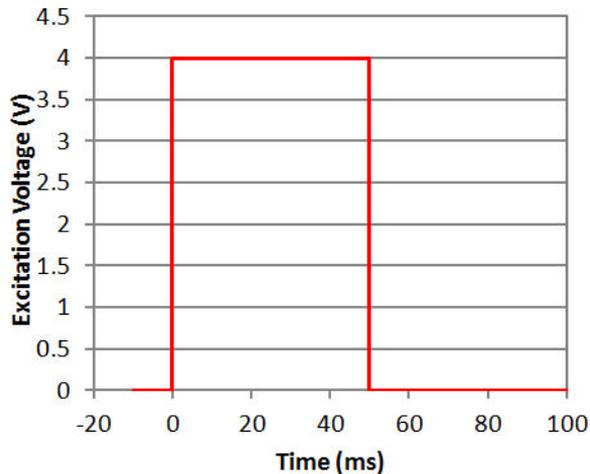
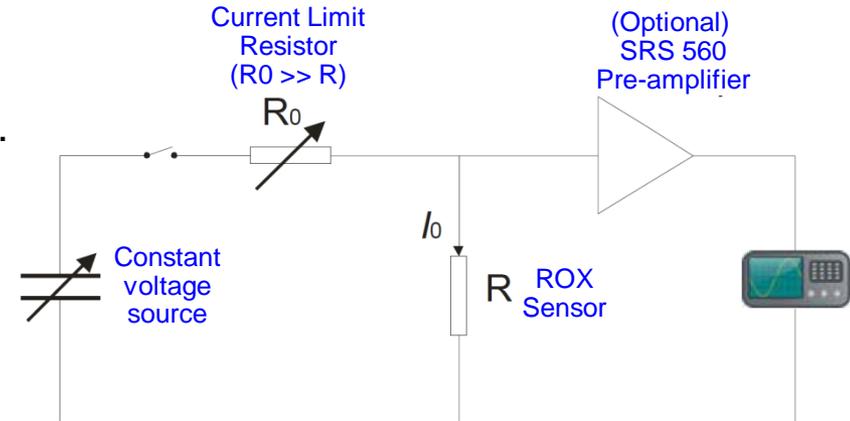
Detecting Superfluid Film

- Procedure for detecting film
 - Abruptly initiate constant current through the ROX
 - Digitize amplified voltage across ROX vs time.
 - No film:
 - If “self-heating” is small, ROX voltage is constant



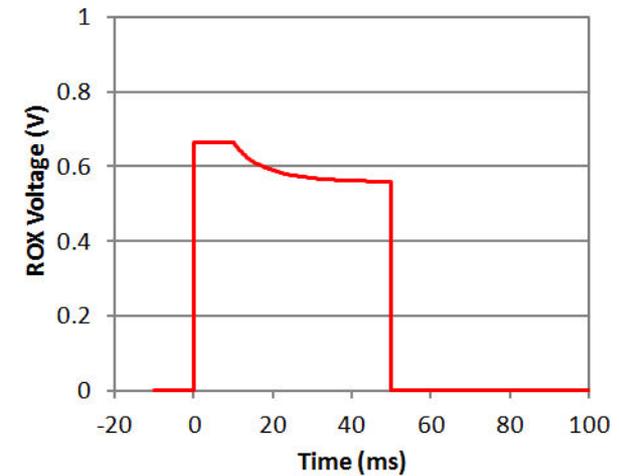
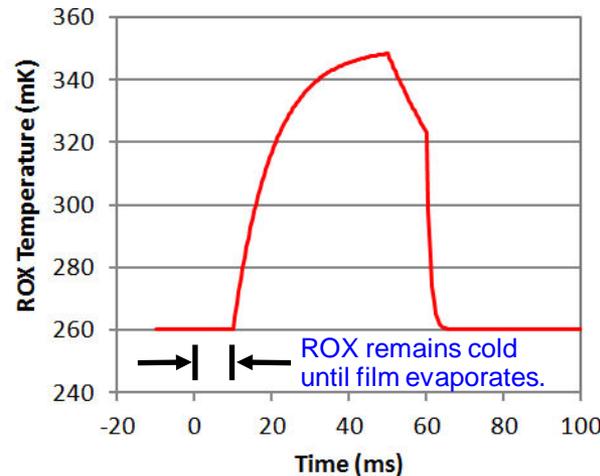
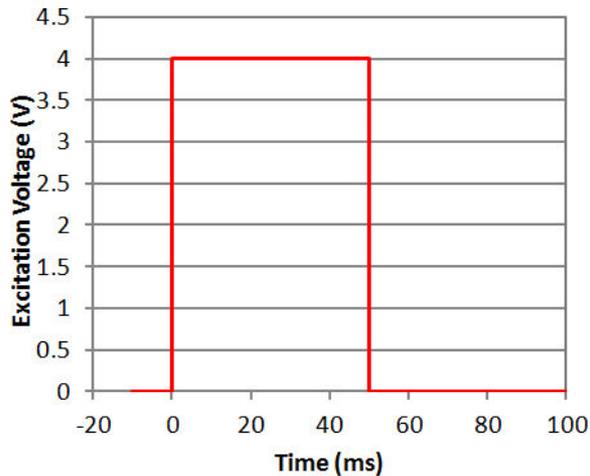
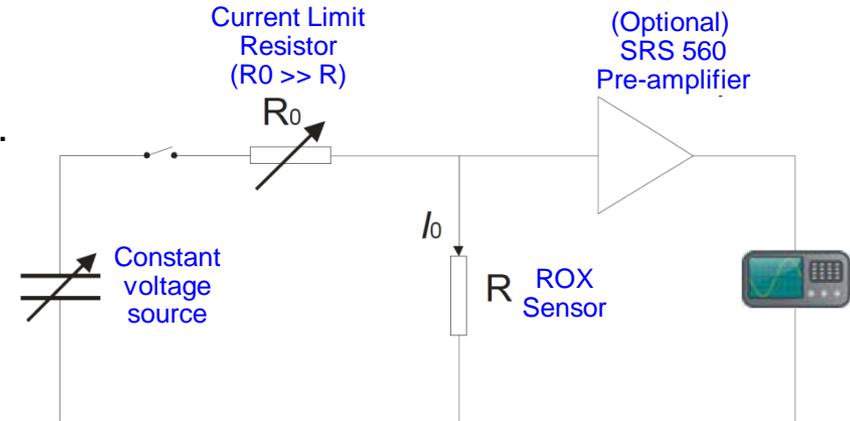
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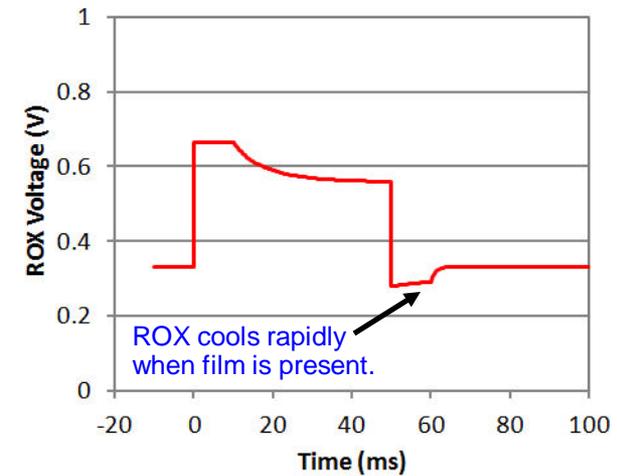
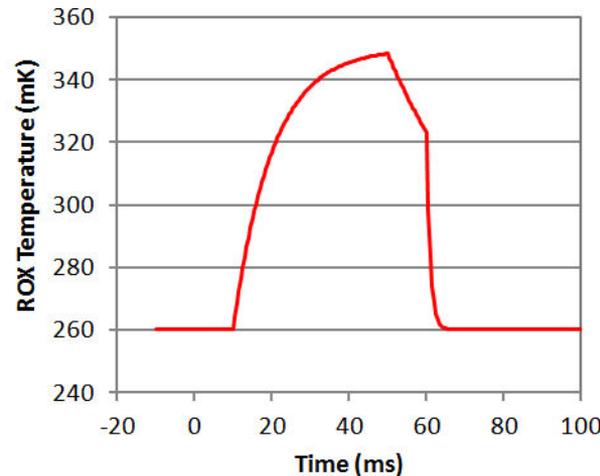
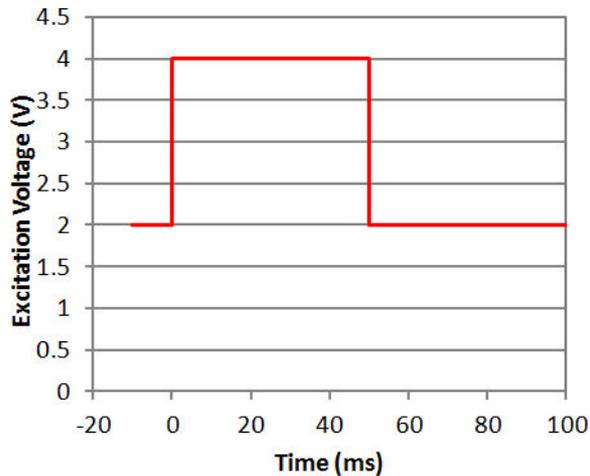
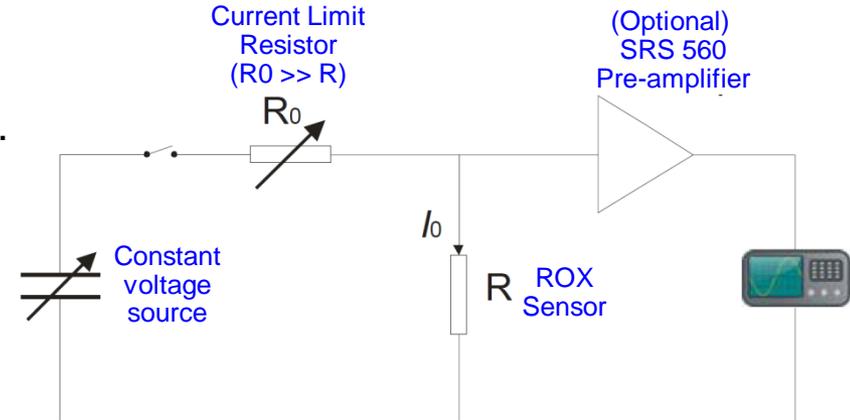
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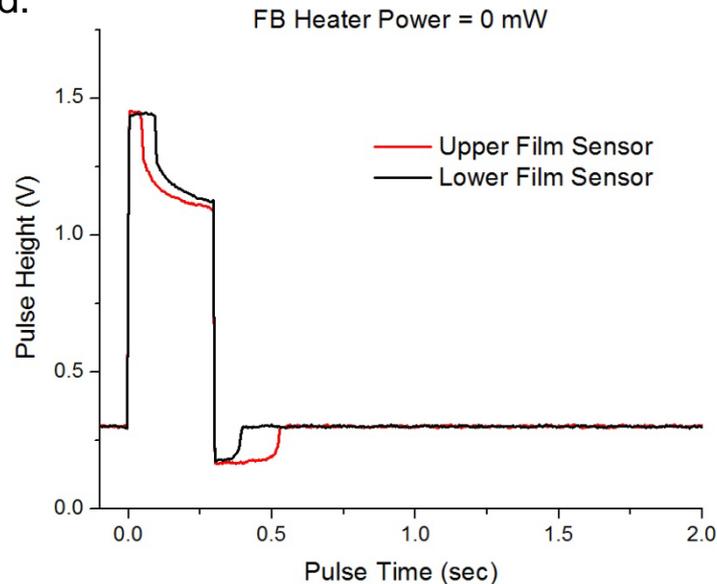
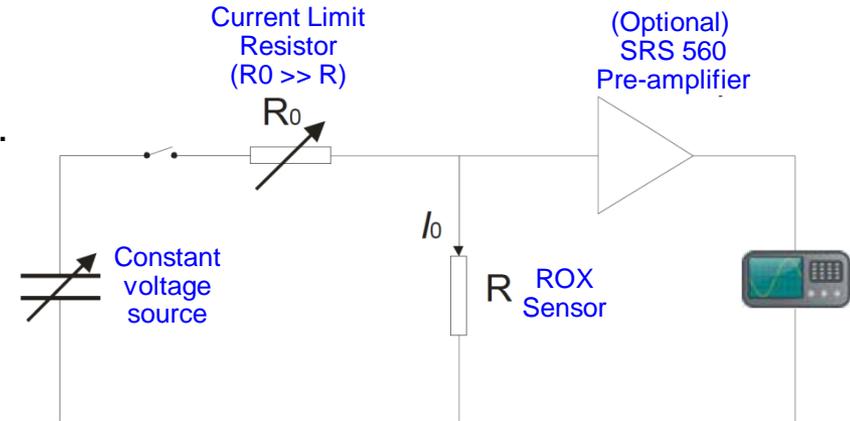
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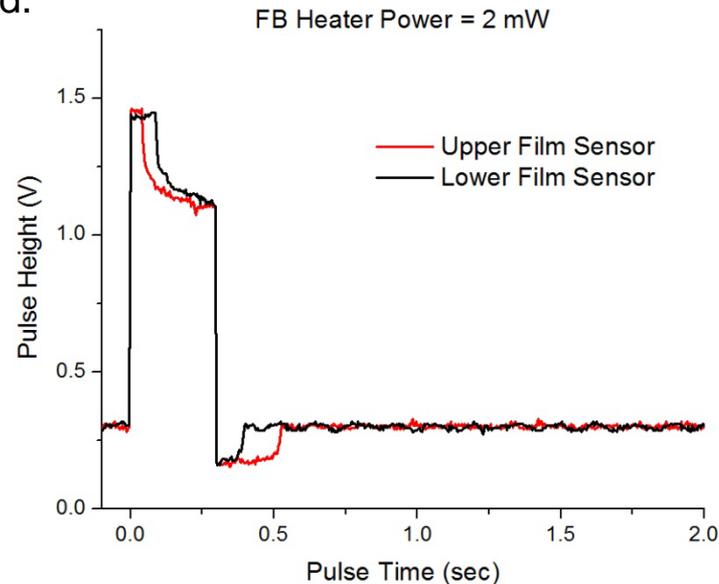
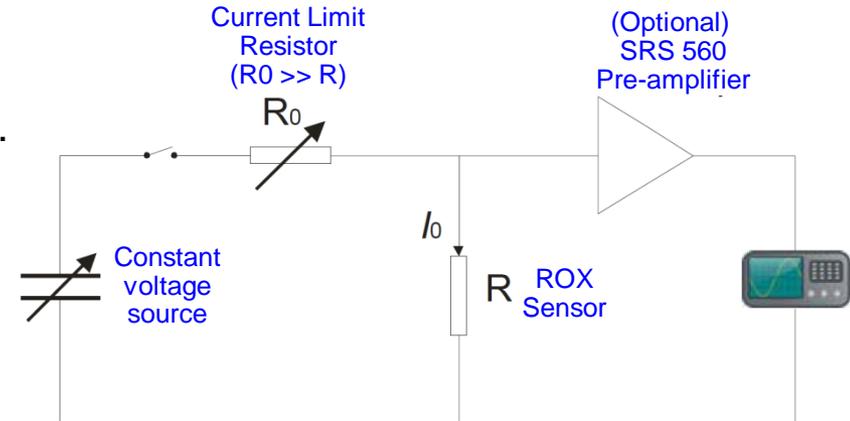
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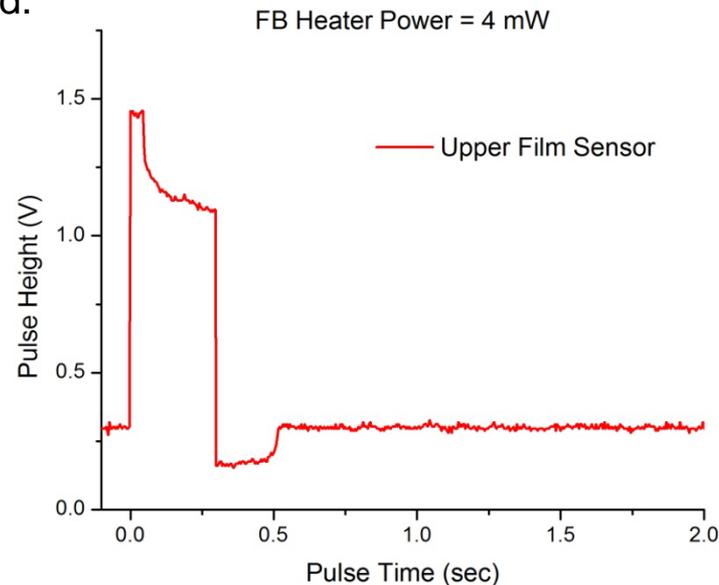
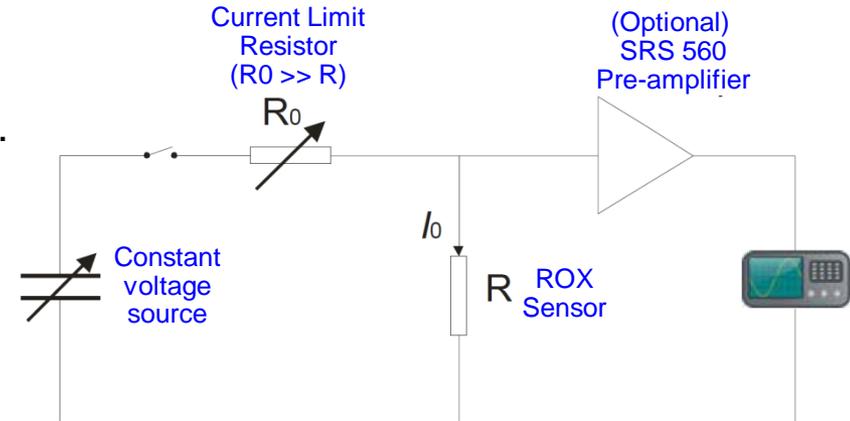
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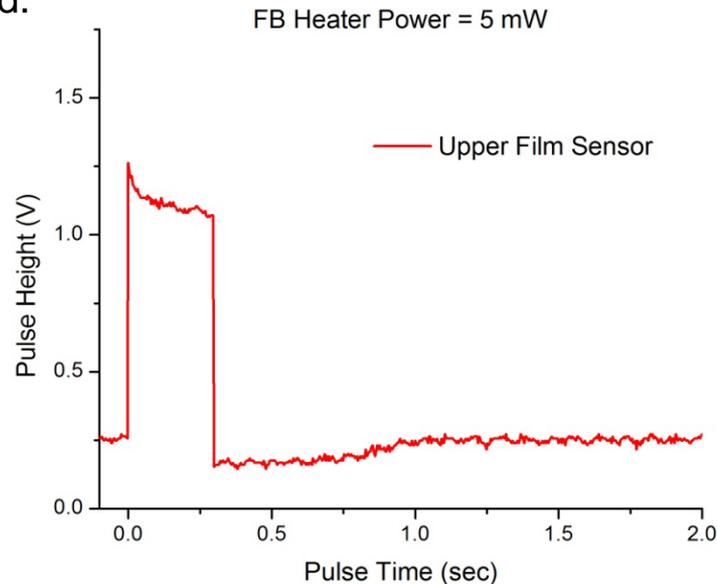
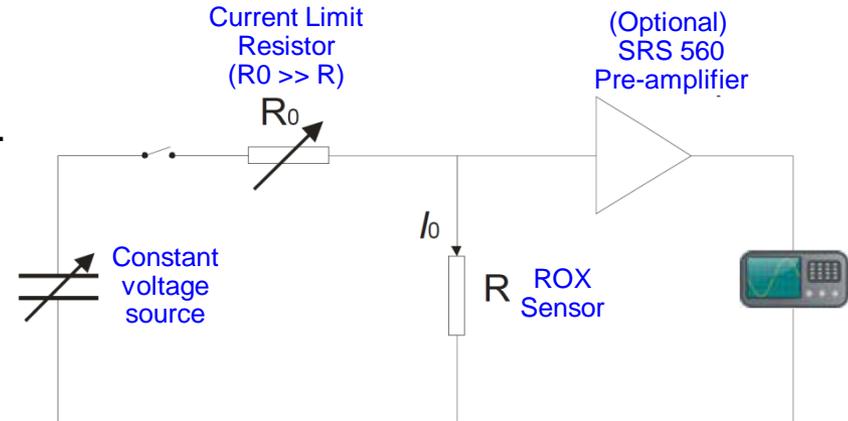
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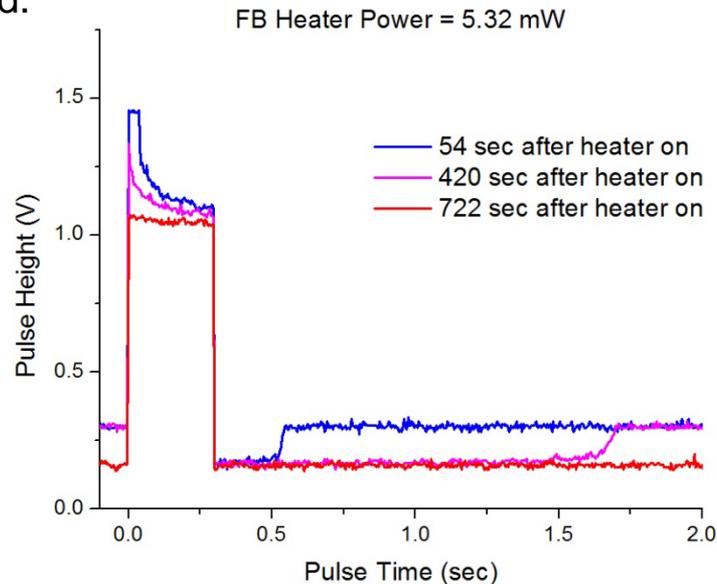
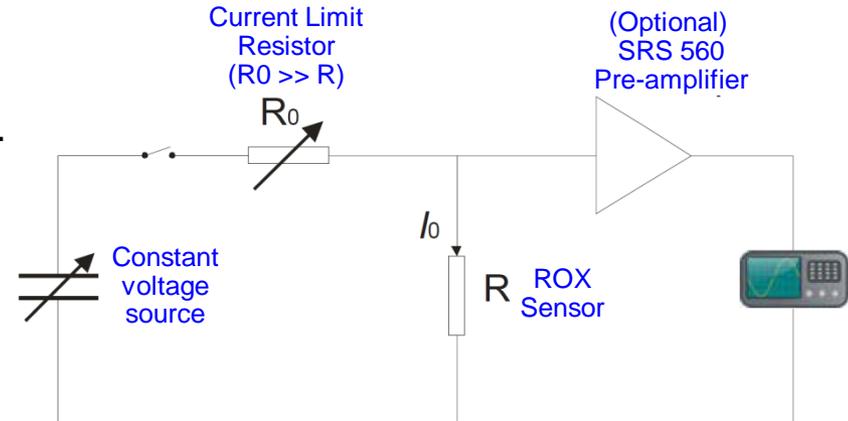
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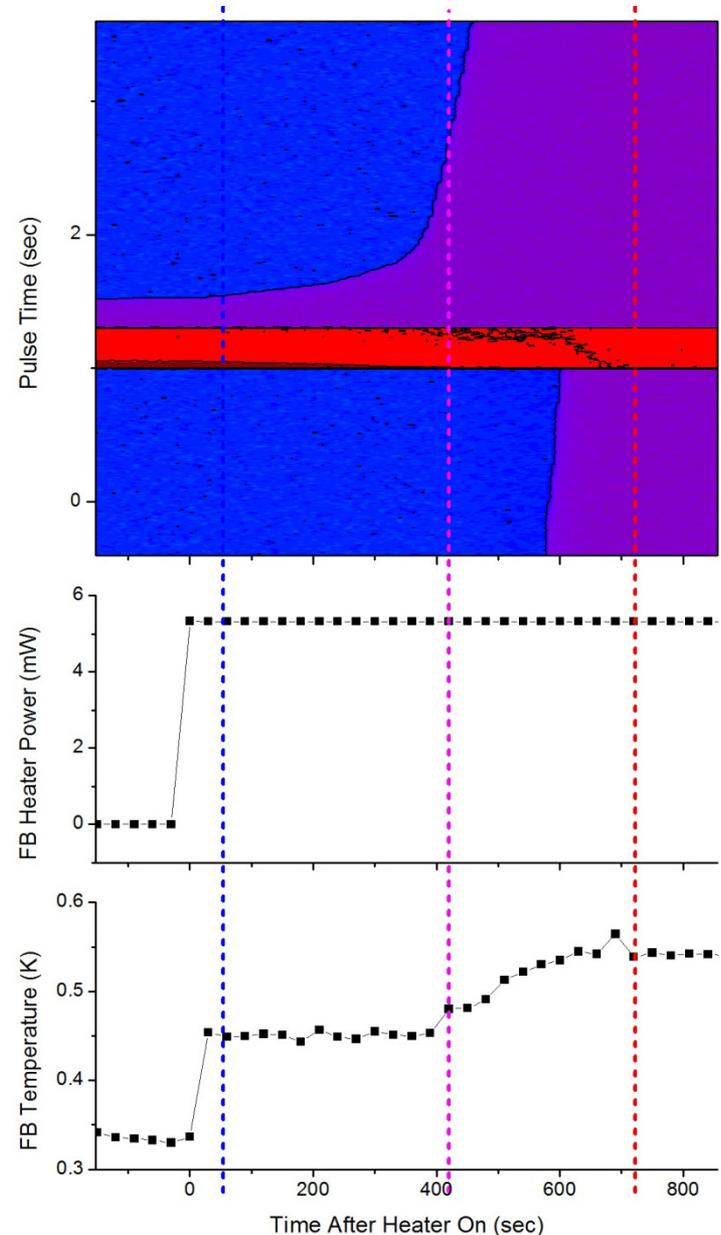
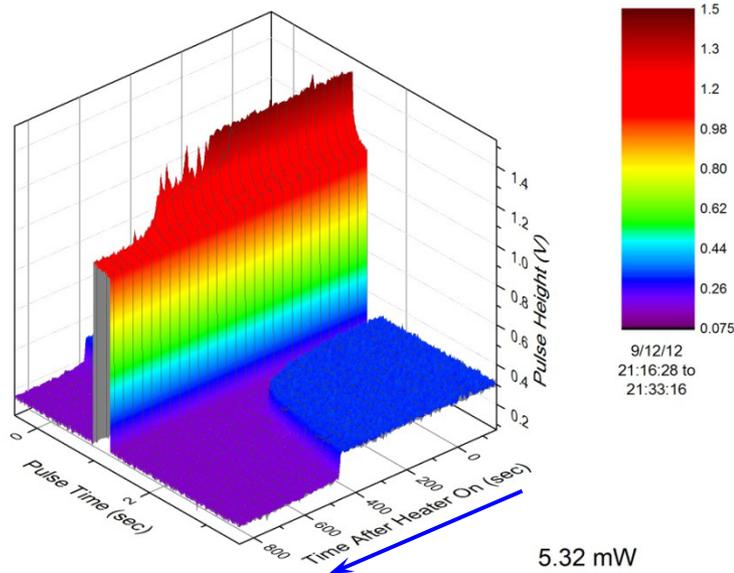
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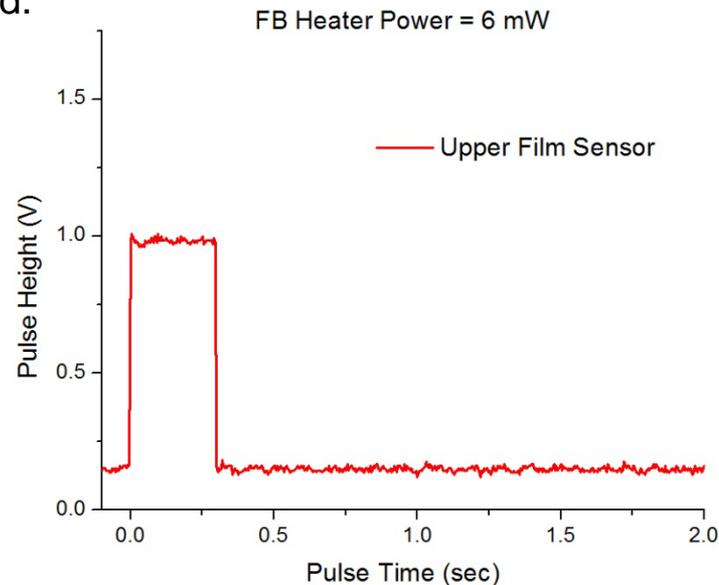
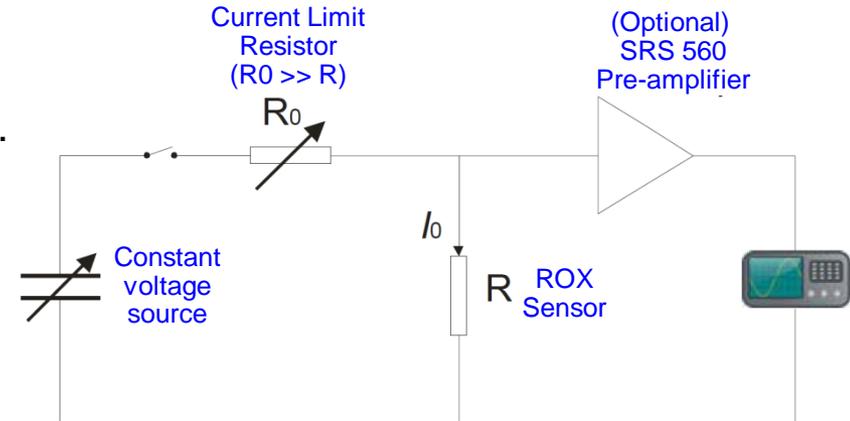
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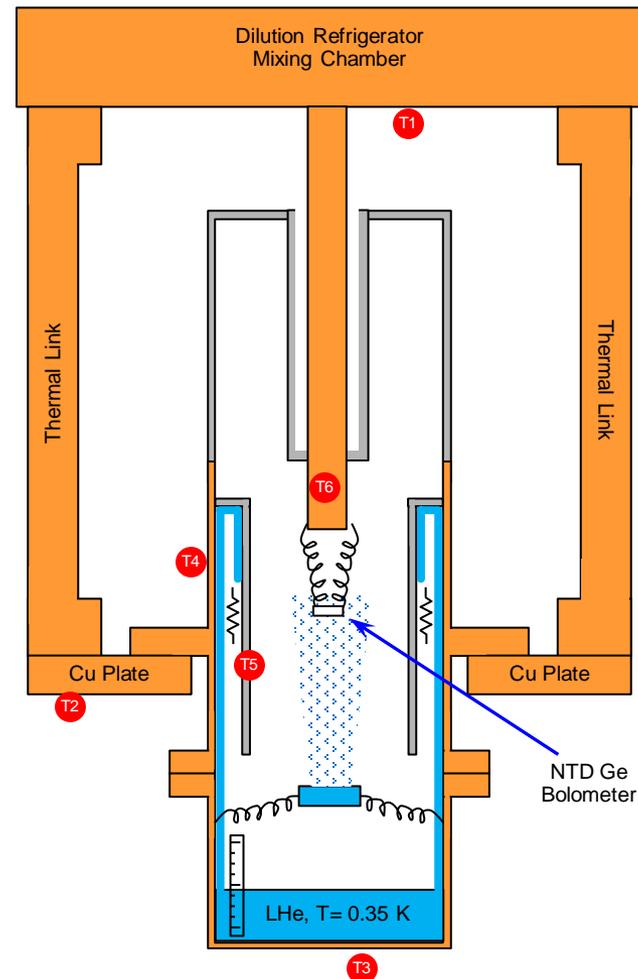
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 - Digitize amplified voltage across ROX vs time.
 - No film:
 - If “self-heating” is small, ROX voltage is constant.
 - If self-heating is significant ROX voltage drops slightly
 - With film: ROX remains cold until film evaporates.
 - If a small offset is applied, the “re-filling” of the film can be observed.



The “Phase 1” Film burner works.

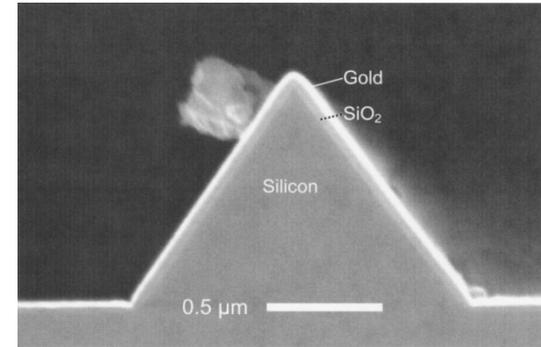
...or does it?

- We can stop the film, but require ~70% more heater power than expected.
 - Surface quality can affect film thickness.
 - Radial “knife edge” may not be smooth
- We don't know that all vapor is recondensed on condenser surface.
 - Test by measuring density of vapor within tube by transmission of ^4He atoms
 - Generate a pulsed “beam” of atomic ^4He
 - Method pioneered* in Ike Silvera's lab
 - Apply a short heat pulse to small surface (Bolometer) coated with ^4He film to evaporate the film
 - Velocities in vapor pulse follow M-B distribution of 0.65-0.8 K
 - Pulse durations from 30-60 μs
 - Pass beam through residual vapor in the “beam line”
 - Flight path ≥ 4 inches
 - Detect unscattered beam
 - Measure temperature rise of a neutron transmutation doped (NTD) germanium bolometer chip
 - Measure versus time to get beam velocity dependence
 - Response time is $\sim 40 \mu\text{s}$

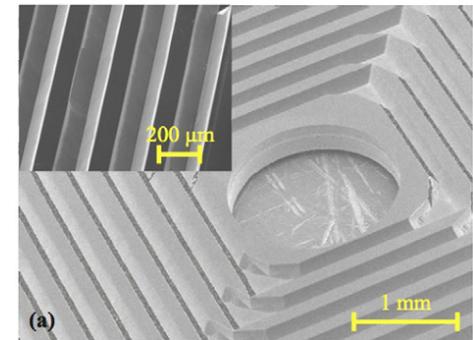


Beyond Phase 1: Phase 2

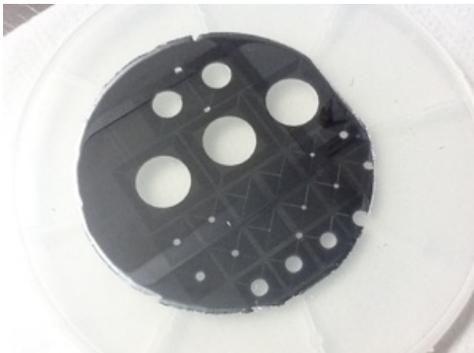
- Realistic dimensions: R_{\min} 50% larger)
- Realistic materials: plastic injection volume
- Realistic cooling:
 - LHe thermal link to MC heat exchanger
 - Cooling jacket and 2-sided sinter on condenser
- Change geometry to reduce heat load:
 - Etched Silicon “film thinner”
 - A Series of VERY sharp edges: film thickness reduced due to large surface tension energy at small radius.
 - Edge must be “atomically sharp” (< 10 nm radius).
 - Currently under study at NCSU



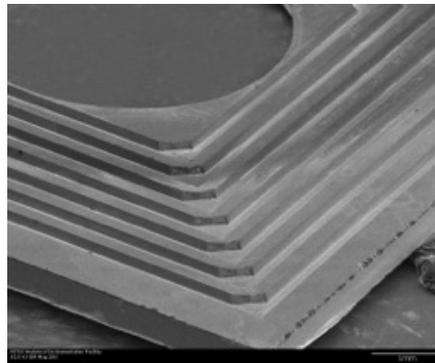
S. J. Spector et al, J. Vac. Sci. Technol. B 216□
2865 (2003)



K. Ishikawa et al, Cryogenics 50, 507 (2010).



Etched 4" wafer at NCSU (D. Haase)



SEM Image of etched wafer (D. Haase)

Backup Slides

Beam Transmission

$$\frac{I_T}{I_0} = \exp \left[\frac{-L}{\lambda_v(T_0)} \right] = \text{Transmission}$$

I_0 = Unattenuated intensity

I_T = Intensity attenuated by gas at T_0

L = Length of scattering region

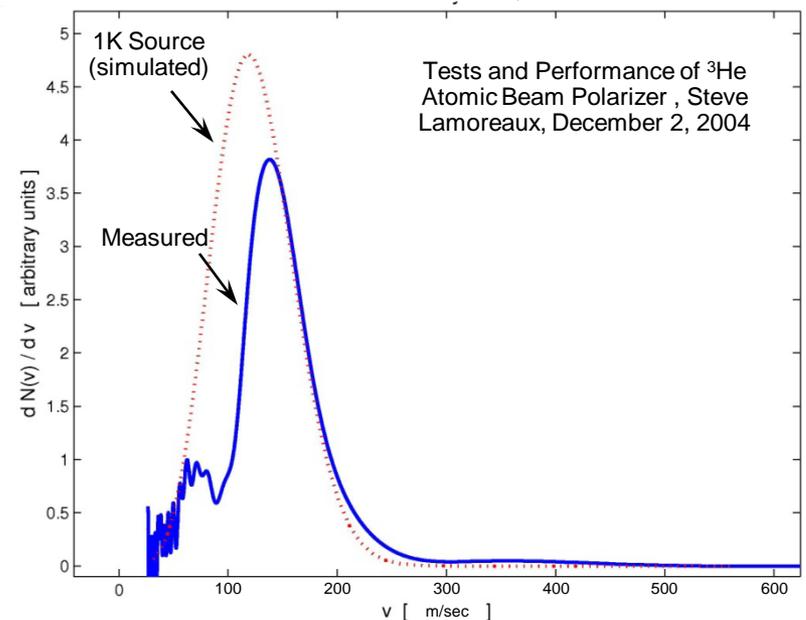
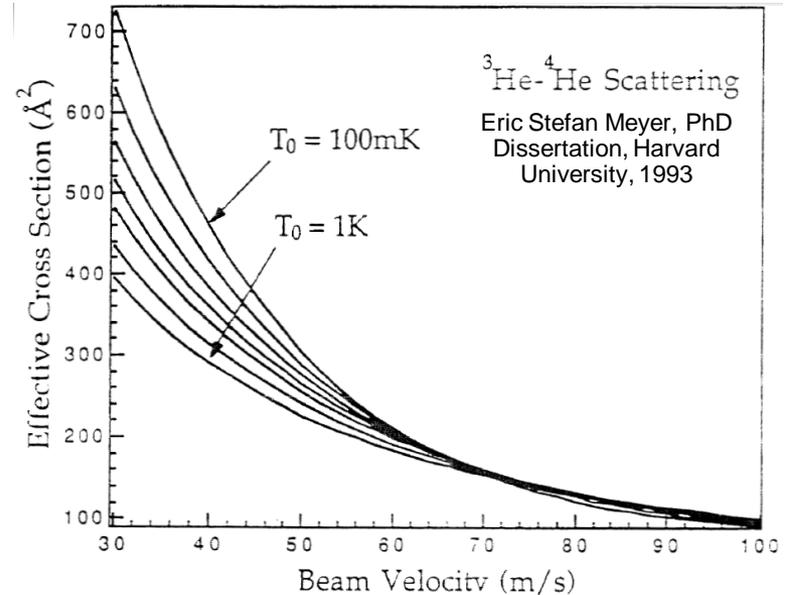
$$\sigma_{eff} = \frac{1}{n \cdot \lambda_v(T_0)}$$

n = target gas density

$\lambda_v(T_0)$ = mean free path of atom with velocity v

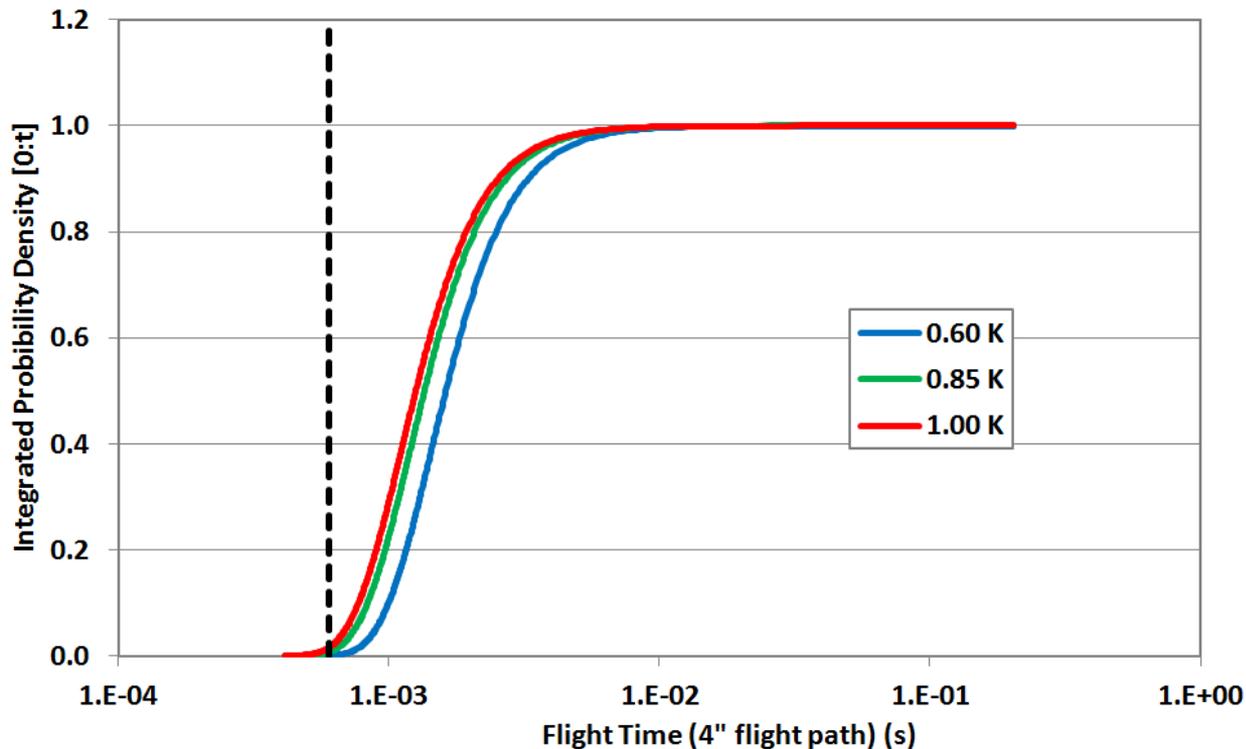
T_0 = Target Temperature

- Most scattering occurs at the low-temperature end of the beam line.
 - Cross section is highest for low target temperature.
 - Density of gas in the beam line goes as $1/T$ (to first order) so is highest at low temperature
- A realistic simulation of the scattering is underway.

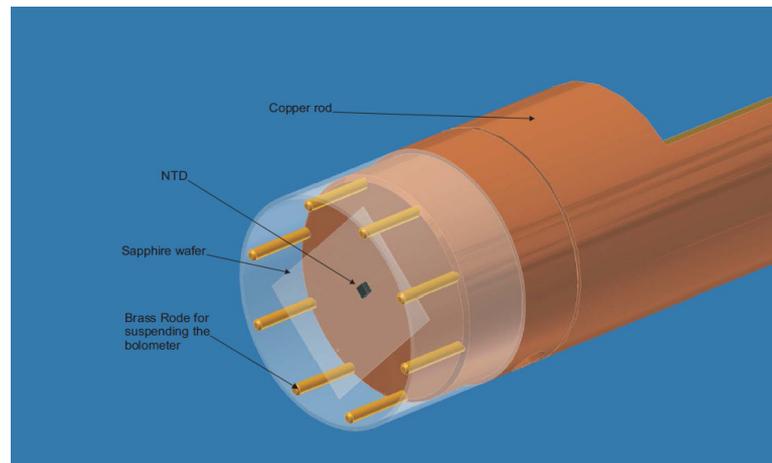
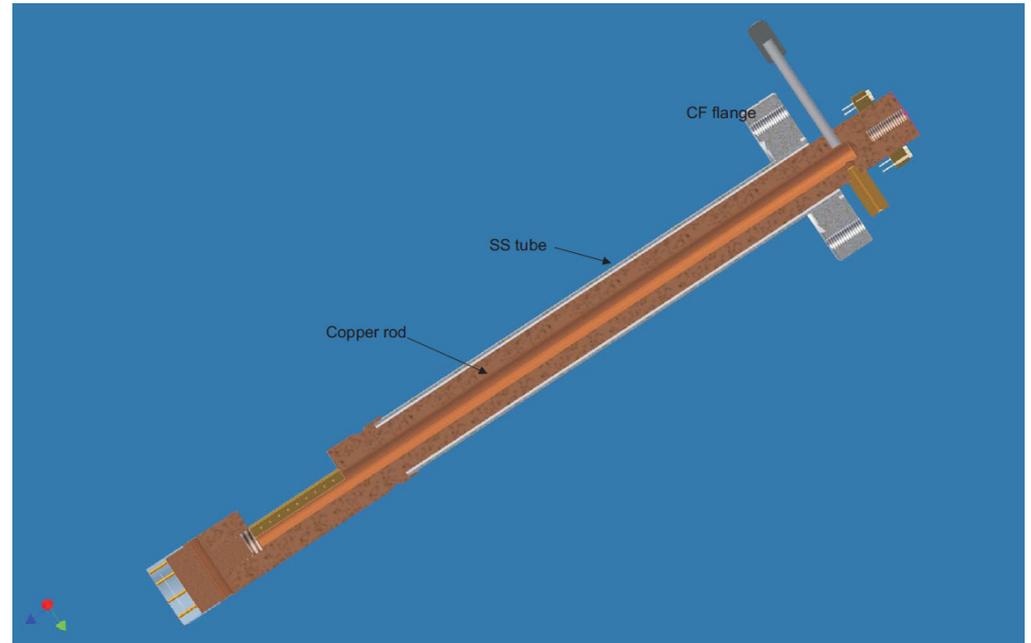
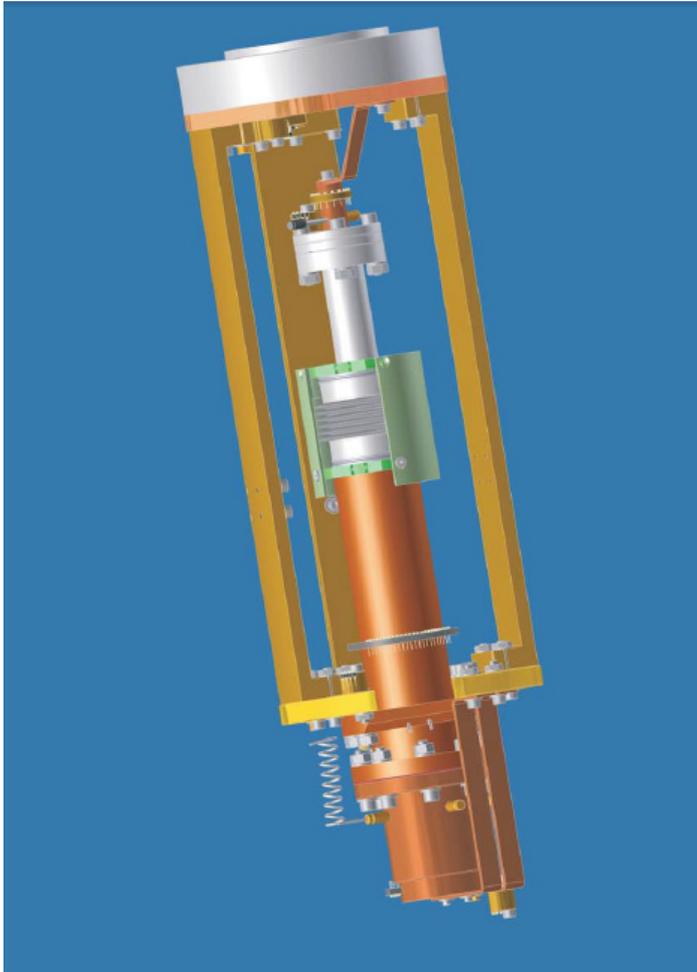


Time-of-flight Resolution

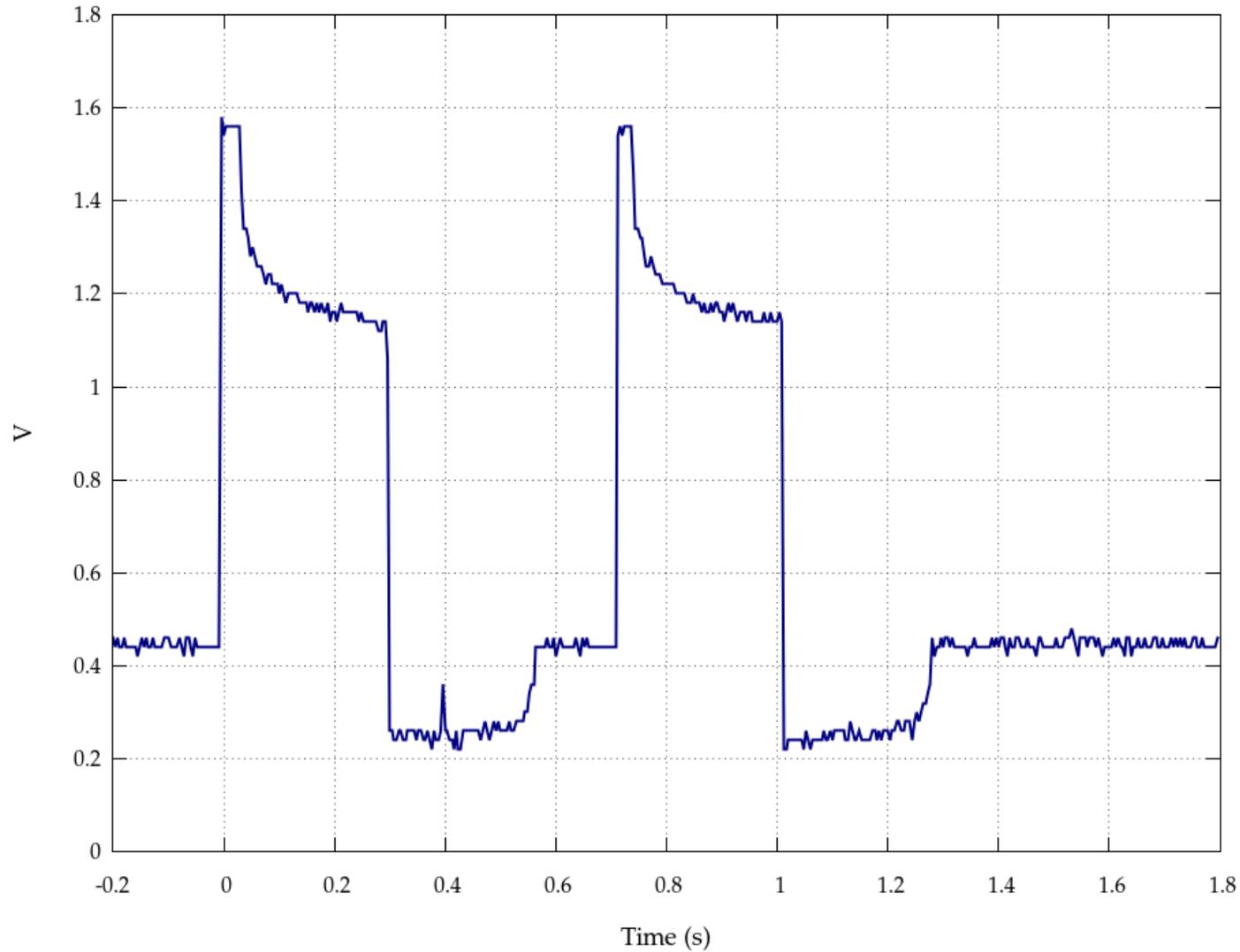
- Want pulse duration $\approx 0.1 \times$ shortest flight time for 10% speed resolution
 - Film evaporates in 30-60 μs
 - Bolometer response is about 40 μs
 - Speed resolution is about 60 μs
 - Lowest flight time should be $\sim 600 \mu\text{s}$
- Conclusion: 4" flight path seems OK (lower temp. evaporator and longer flight path would be better)



Phase 1 with NTD Ge Cold Finger

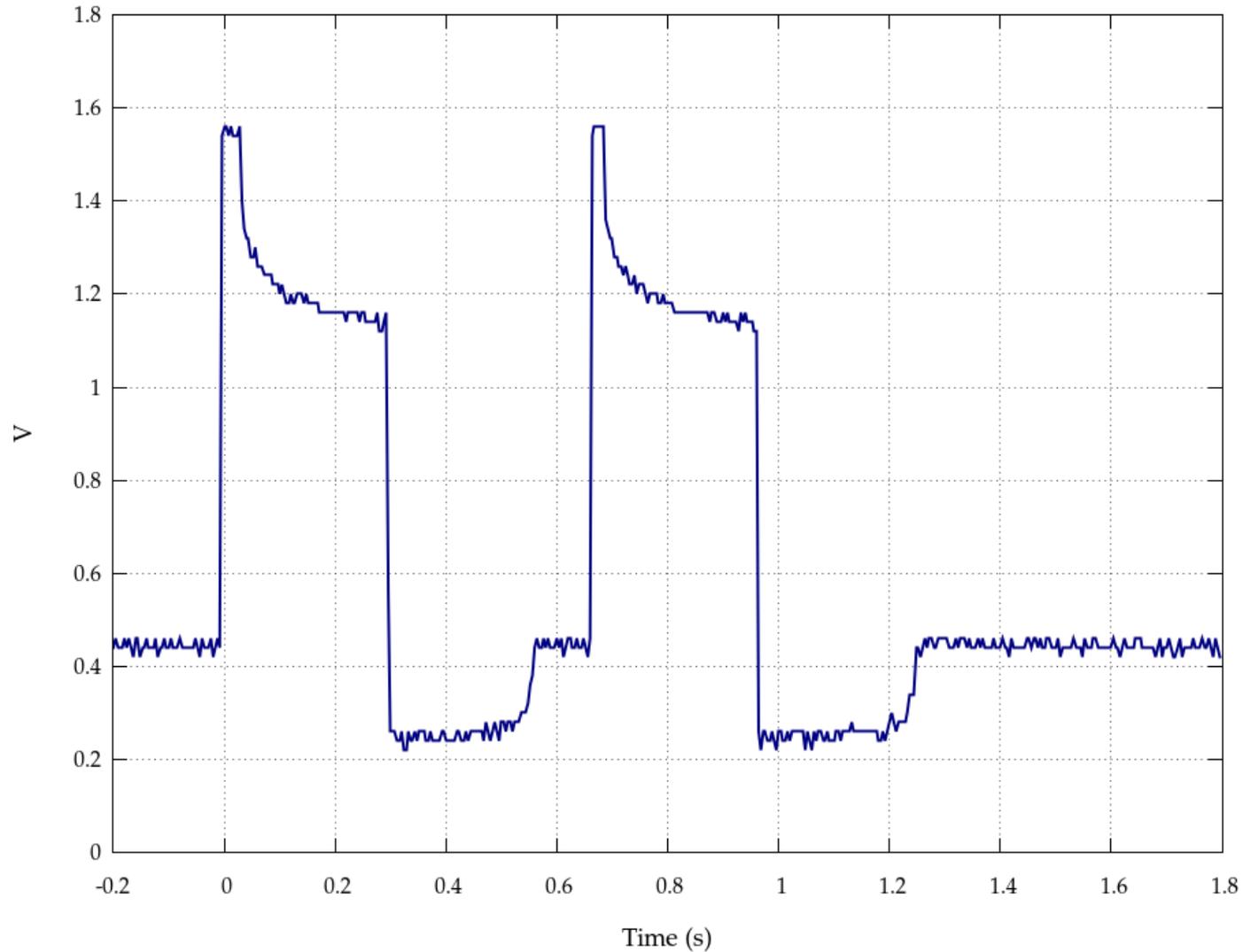


Detecting Superfluid Film



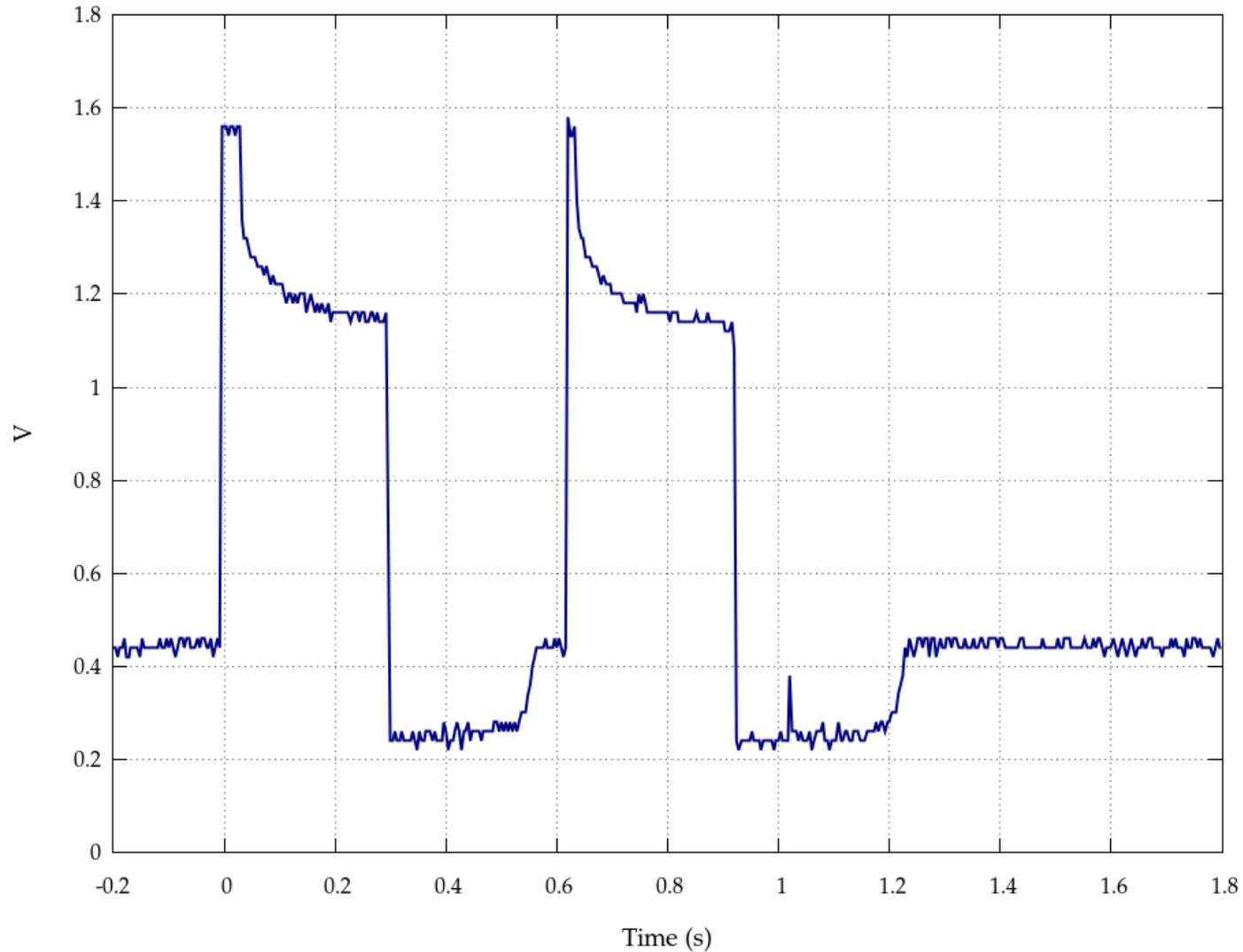
Top ROX, with LHe, 90 mK, 45 kOhm, 4 V pulses

Detecting Superfluid Film



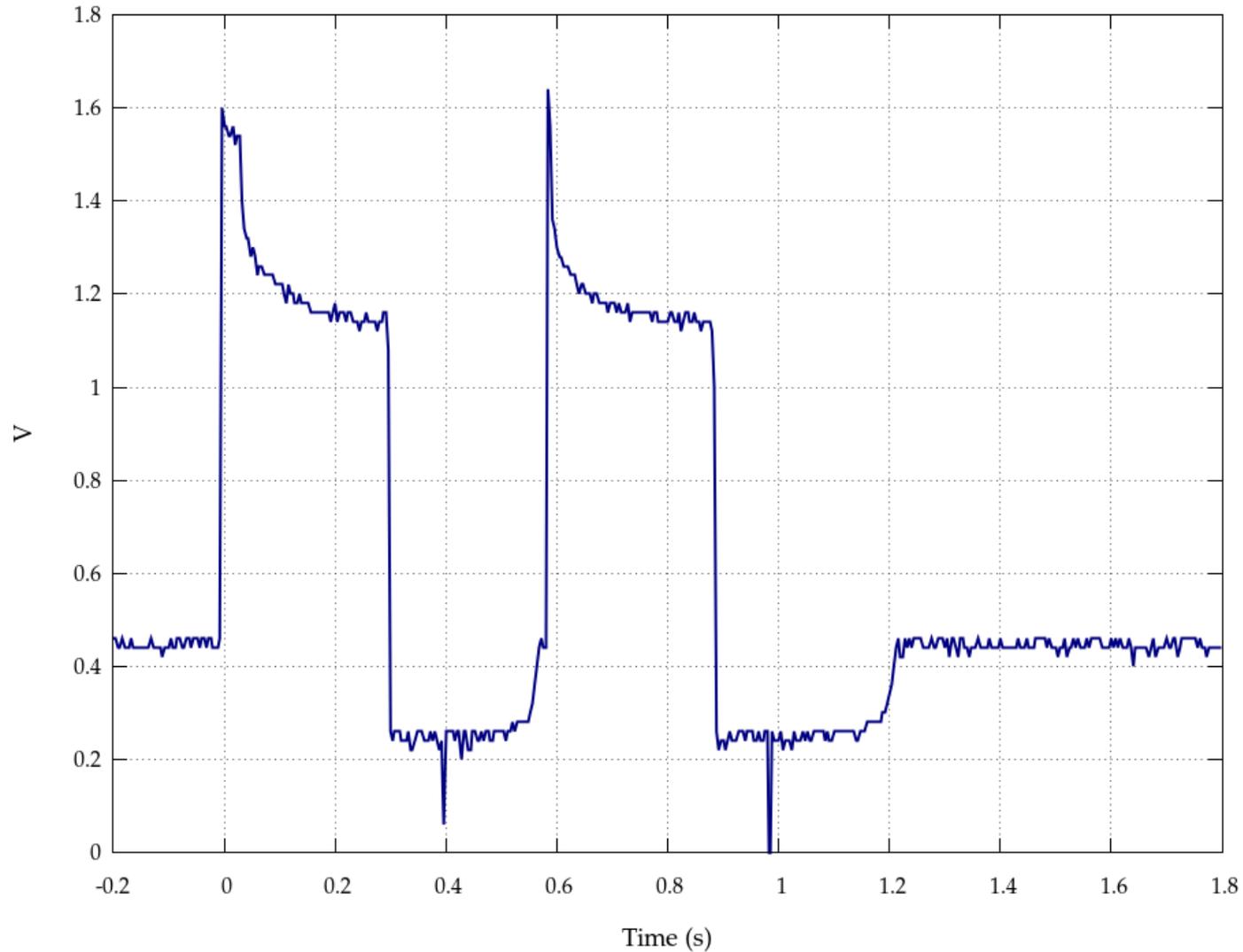
Top ROX, with LHe, 90 mK, 45 kOHm, 4 V pulses

Detecting Superfluid Film



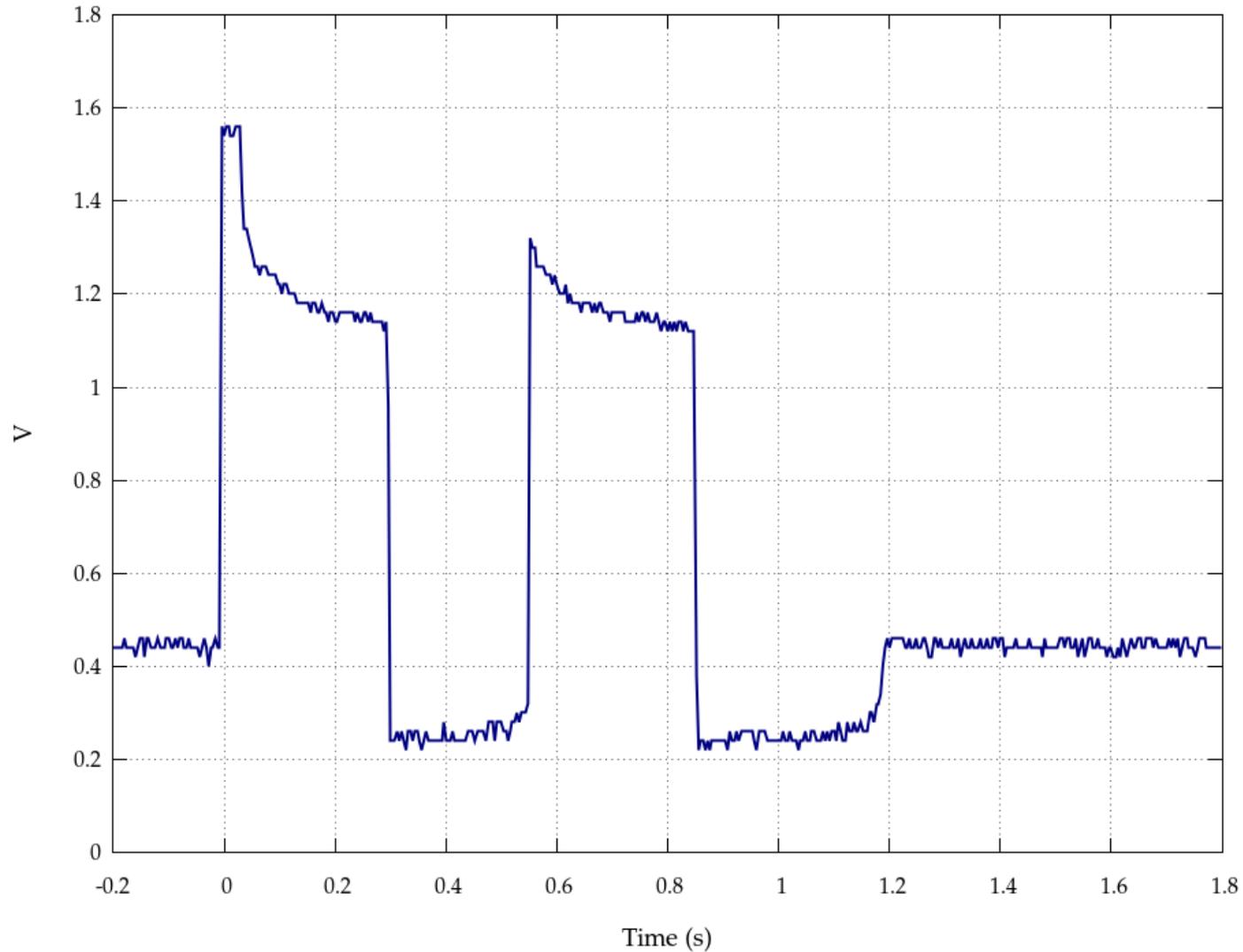
Top ROX, with LHe, 90 mK, 45 kOhm, 4 V pulses

Detecting Superfluid Film



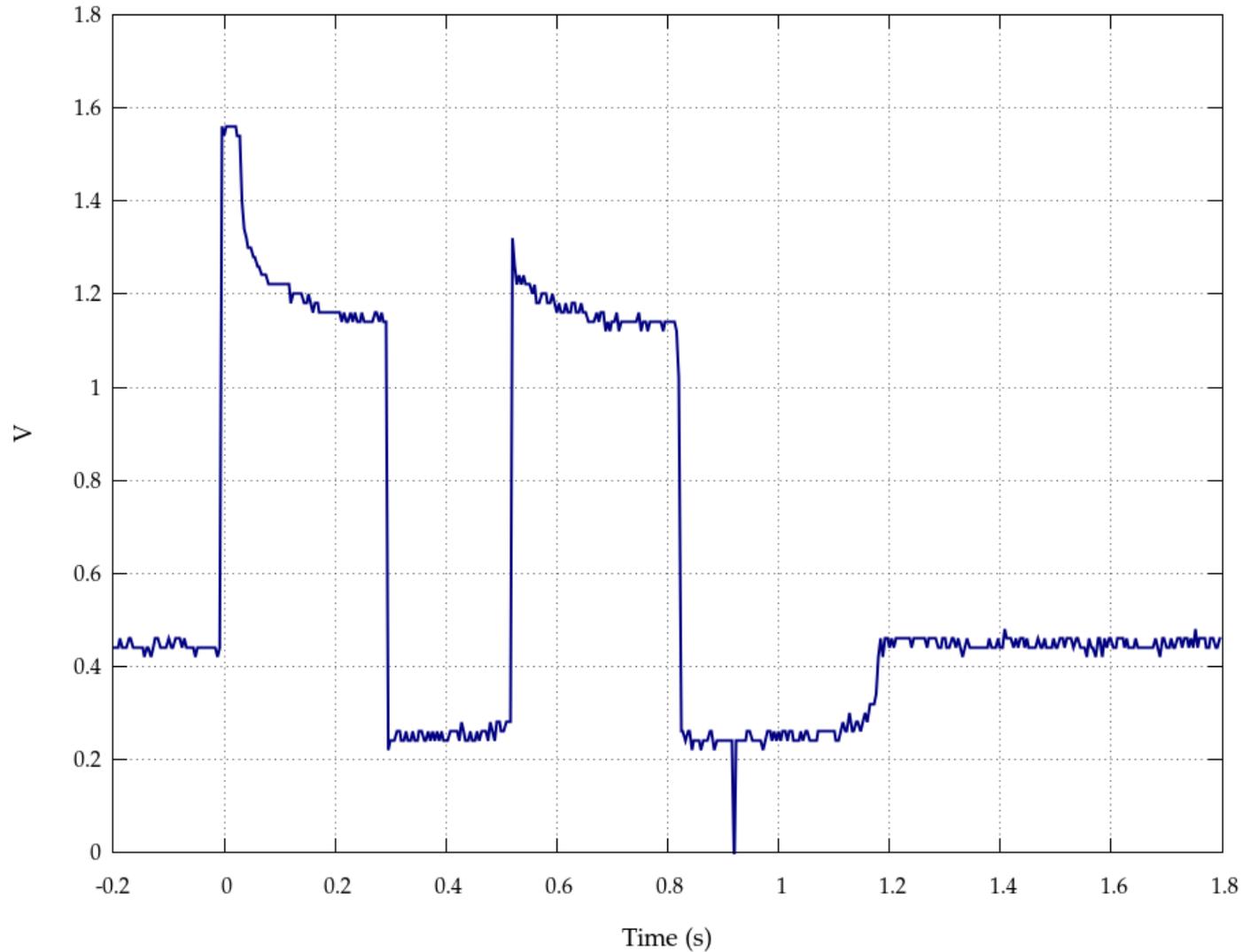
Top ROX, with LHe, 90 mK, 45 kOhm, 4 V pulses

Detecting Superfluid Film



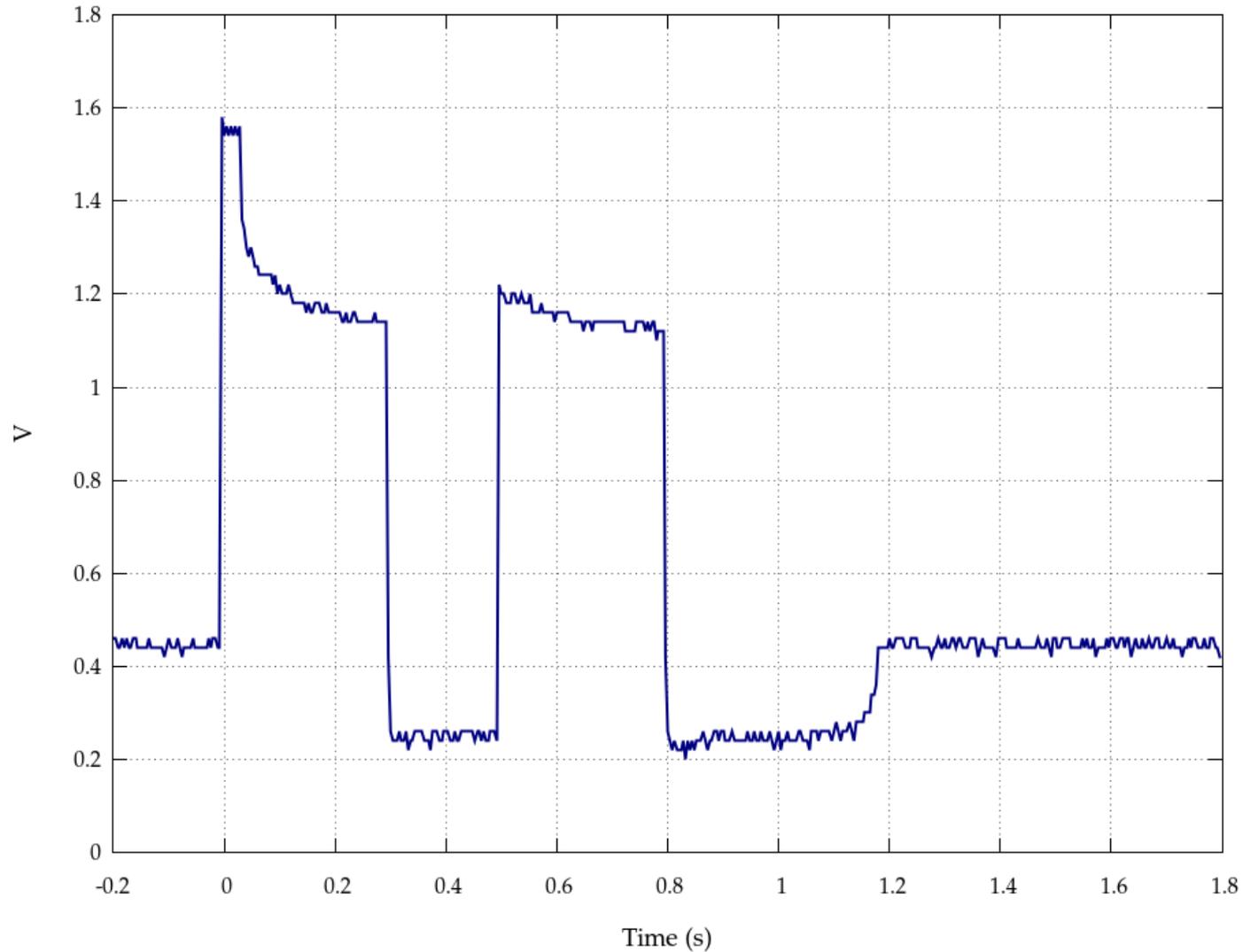
Top ROX, with LHe, 90 mK, 45 kOHm, 4 V pulses

Detecting Superfluid Film



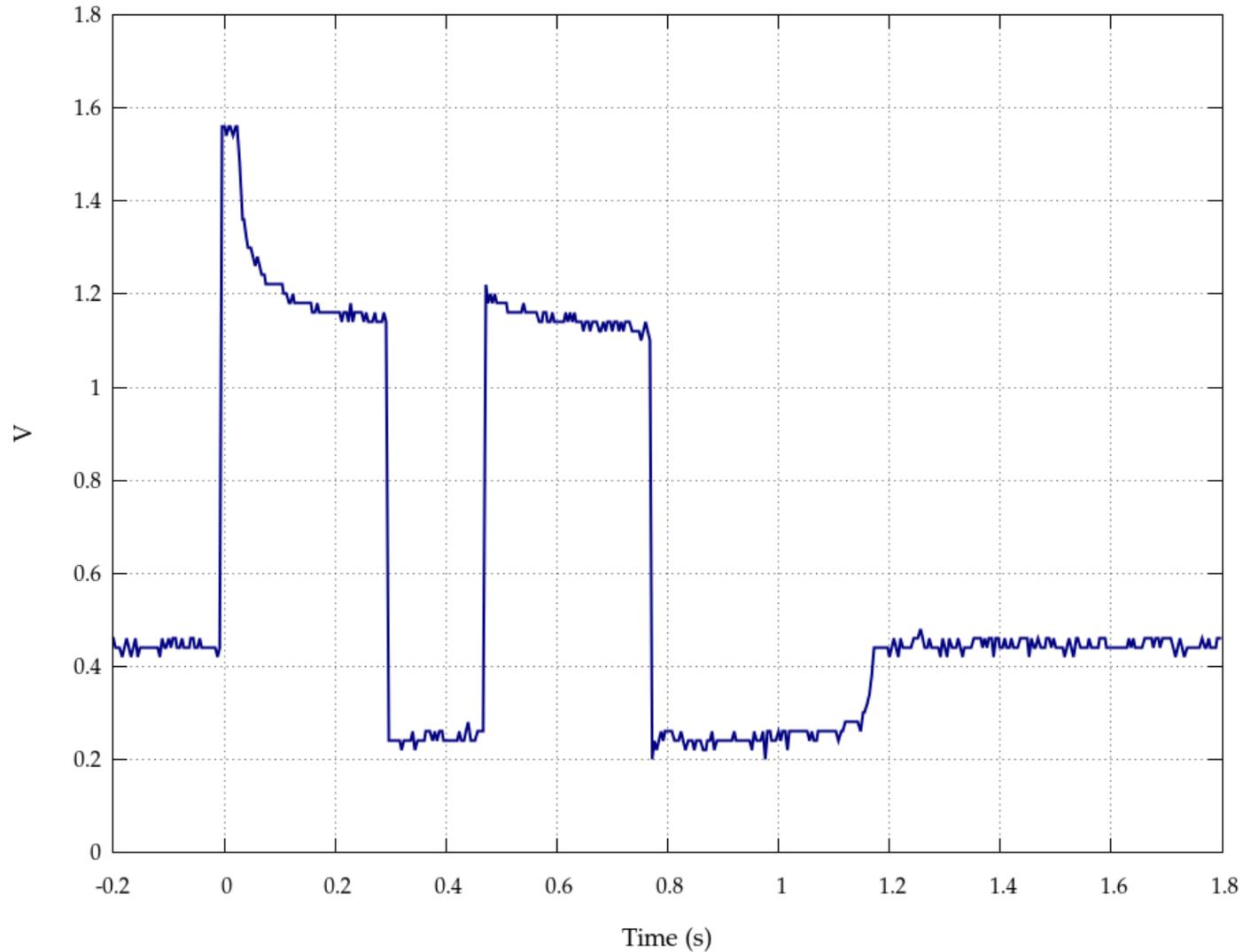
Top ROX, with LHe, 90 mK, 45 kOhm, 4 V pulses

Detecting Superfluid Film



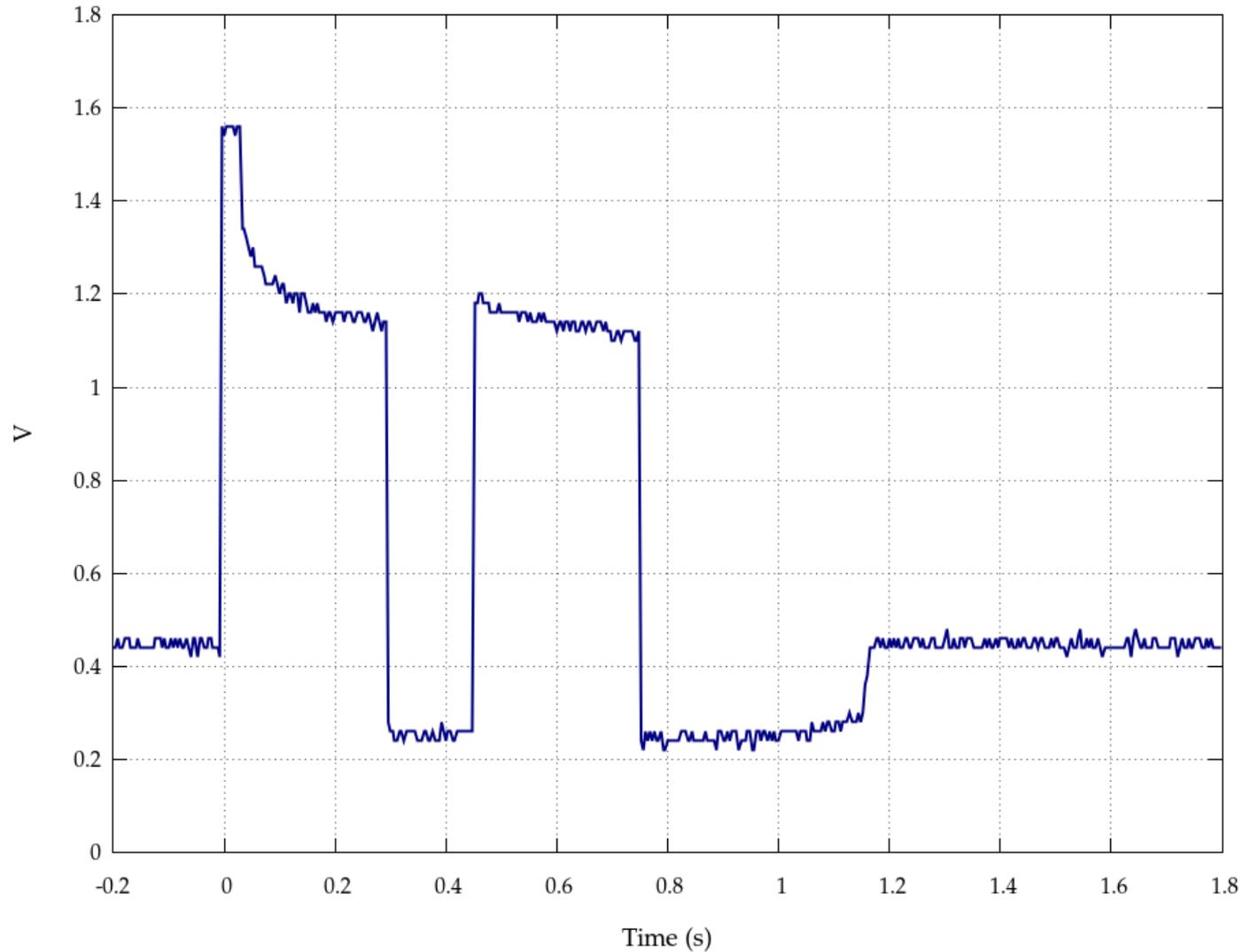
Top ROX, with LHe, 90 mK, 45 kOHm, 4 V pulses

Detecting Superfluid Film

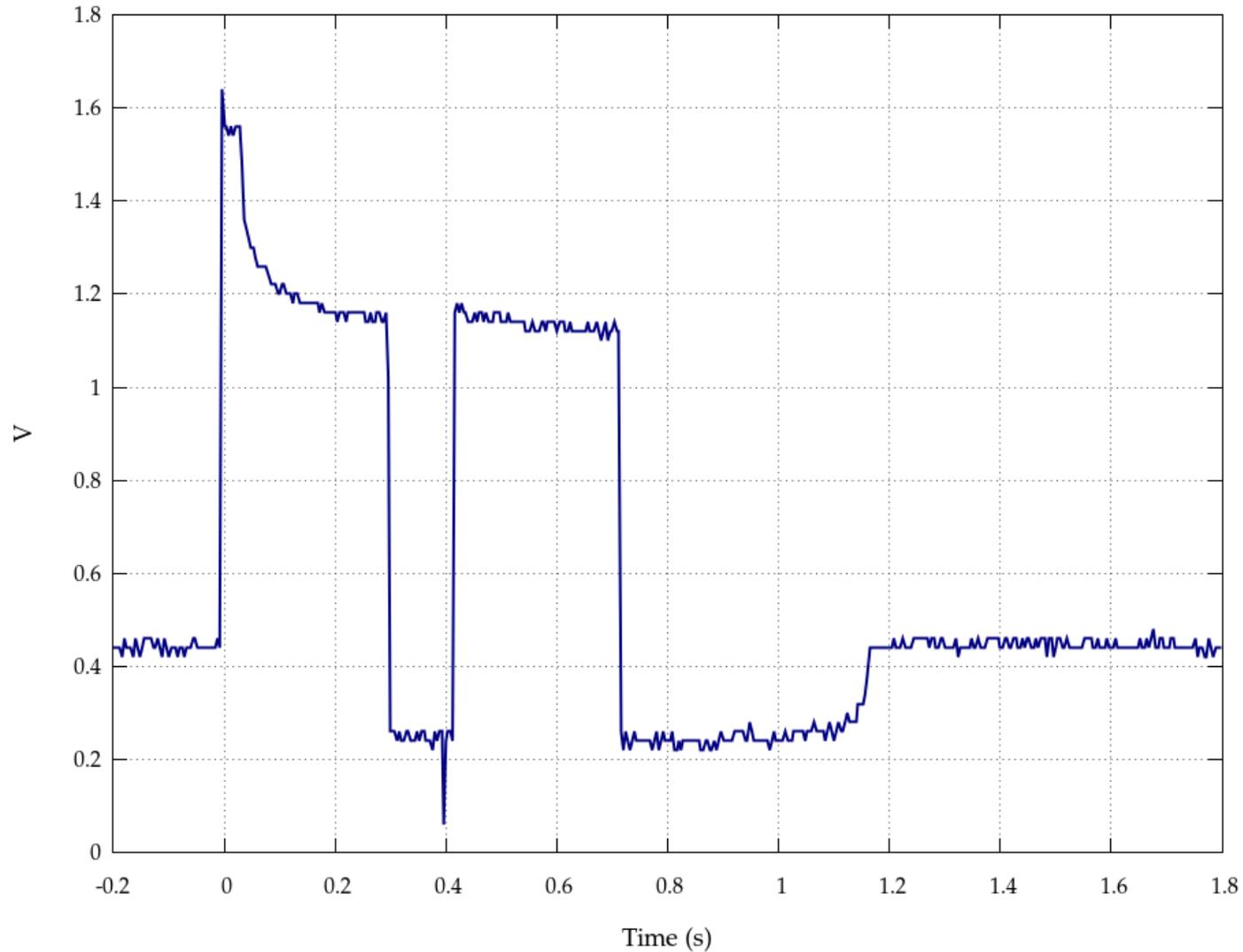


Top ROX, with LHe, 90 mK, 45 kOHm, 4 V pulses

Detecting Superfluid Film



Detecting Superfluid Film

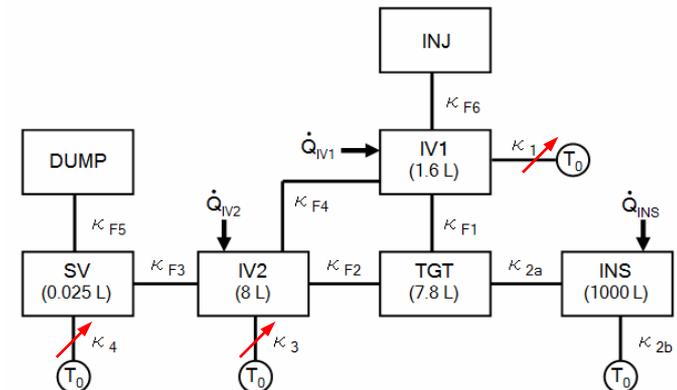


Top ROX, with LHe, 90 mK, 45 kOHm, 4 V pulses

Heat Budget

Subsystem [†]	Source	Amount (mW)	Basis of Estimate
General	Radiative heating to insulation volume and ³ He/ ⁴ He volumes	0.2	Calculation, emissivity = 1
	Mechanical support to 1.5 K	5	Calculation x 5
	Conduction through Electrical Leads	1	Calculation x 5
³ He Heat Flush	Heater currents	20	Flow calculations from ³ He services group
Purifier	Film Burner	6	Calculation x 2
	Valves	1.5	2 @ 0.75 mW
	Bellows	1.5	1 @ 1.5 mW
Injector	Radiation through injection pipe	2	Calculation x 10
	Film burner	6	Calculation x 2
Light Guides and PMTs	Radiative heating from 8 K	3	Calculation (includes 15 K PMT's) x 2
Valves		10	10 valves @ 1.0 mW
Bellows		6	2 bellows @ 3 mW
Magnets	I ² R Losses, eddy currents	15	
Contingency	Project management	20	
Total Heat Load to DR at 0.35 - 0.40 K		88.2	

- Heat flush transport is one of the largest sources of heat load.
- A thermal model[‡] of the apparatus and measurement cycle indicates:
 - Closed valves should have low thermal conductance (< 1 mW/K)
 - Adjustable thermal links (ATLs) will reduce the overall heat load

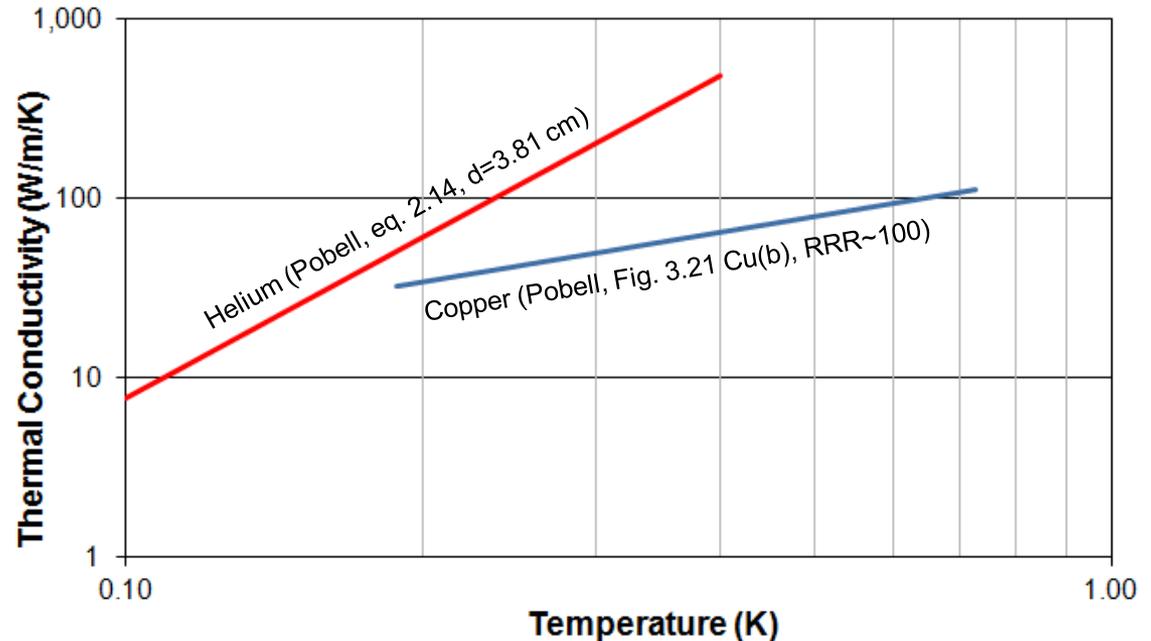


[†] D. Haase, Heat Budgets and Other Items, a presentation at the June 17-19, 2009 nEDM Collaboration.

[‡] D. Kendellen and D. Haase, An Updated Thermal Model for Cooling the nEDM ³He Services, a Technical Feasibility, February 23, 2010.

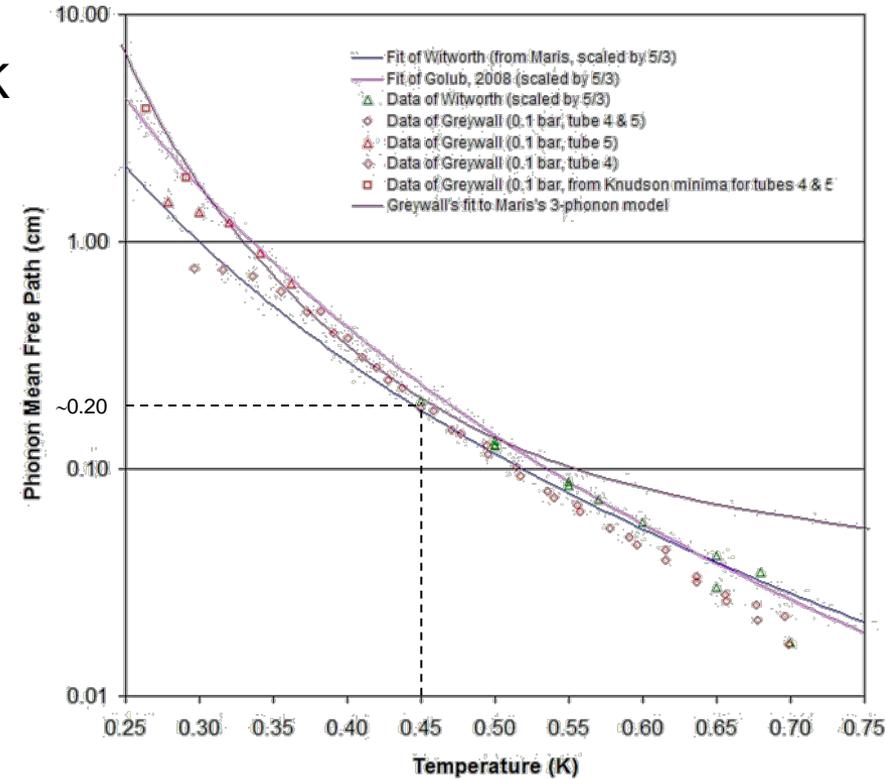
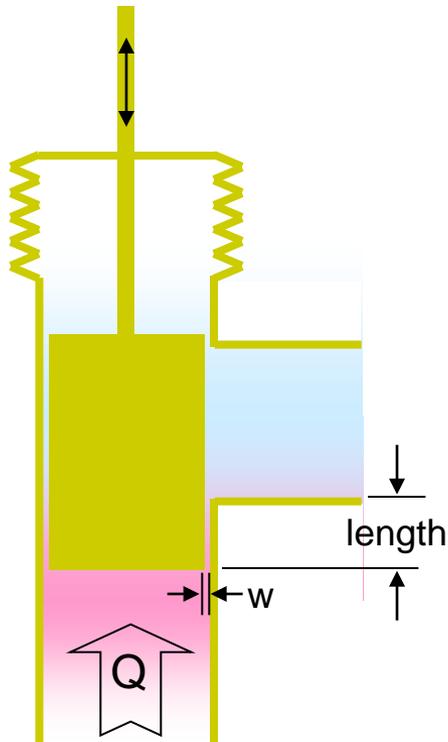
Adjustable Thermal Links (and Valves)

- Bolted joints can have poor thermal conductance (unless care is taken)
- Helium is still a pretty good thermal conductor at 0.45 K
 - Kapitza resistance is not so bad at this temperature
 - Offers the possibility of adjustability (adjustable thermal links)
- ATLs are useful for:
 - Reducing the heat load on DR when components are warmed during heat flush...
 - While allowing rapid re-cooling when the heat flush is over.



ATL Principle of Operation

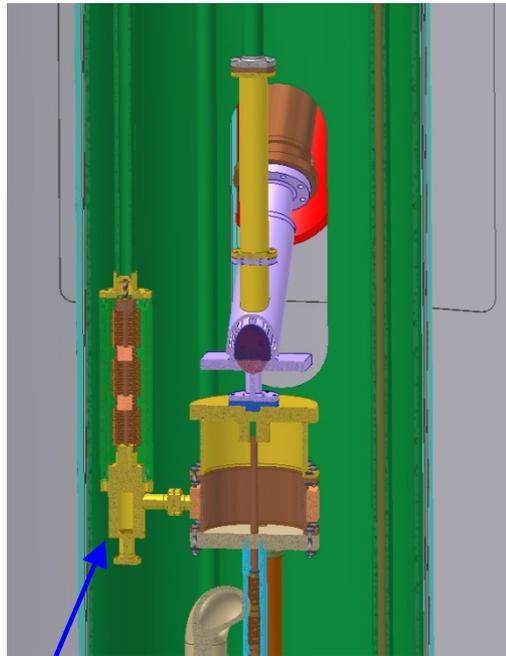
- Heat transport is via phonons for $T < 0.6$ K
- If mean free path of phonons, λ_{ph} , is geometrically restricted, the effective conductivity is reduced.
 - Need typical dimension $\ll \lambda_{ph}$
 - $\lambda_{ph} \approx 0.2$ cm at 0.45K



- Create restriction with adjustable-length annular gap
 - Restriction (w) must be \sim a few mils ($\sim 50X$ smaller than λ_{ph})
 - Wall and plug material must have low conductivity compared to LHe

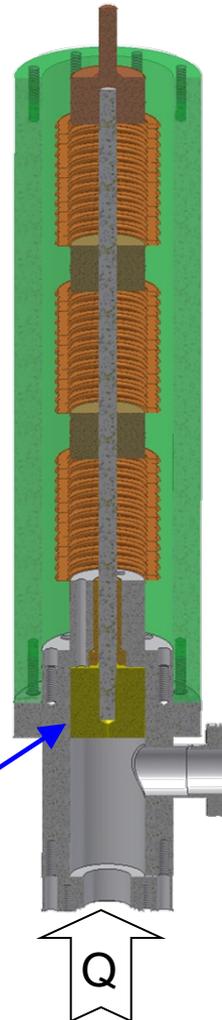
Implementation in the CAD Model

In the Injection Module



IV1 ATL

To actuator

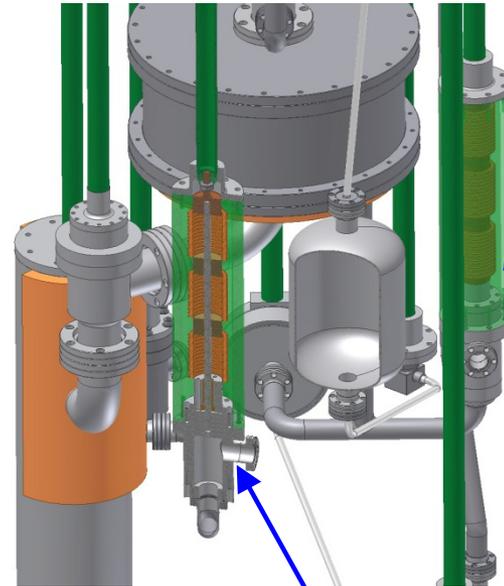


Plug

Multiple bellows (~2" motion)

To DR mixer heat exchanger

In the Purifier Module

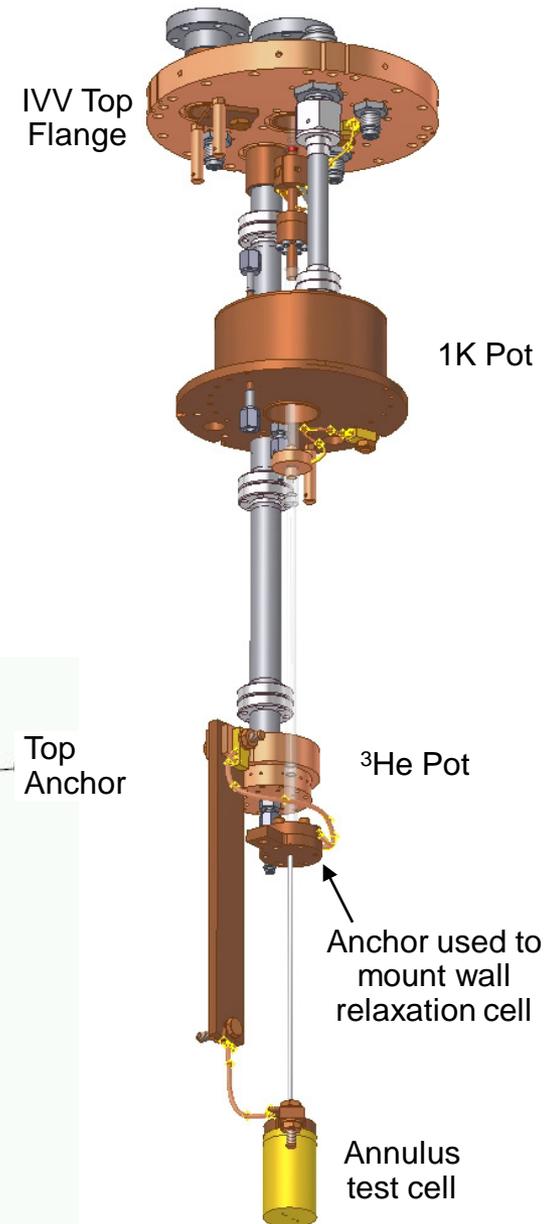
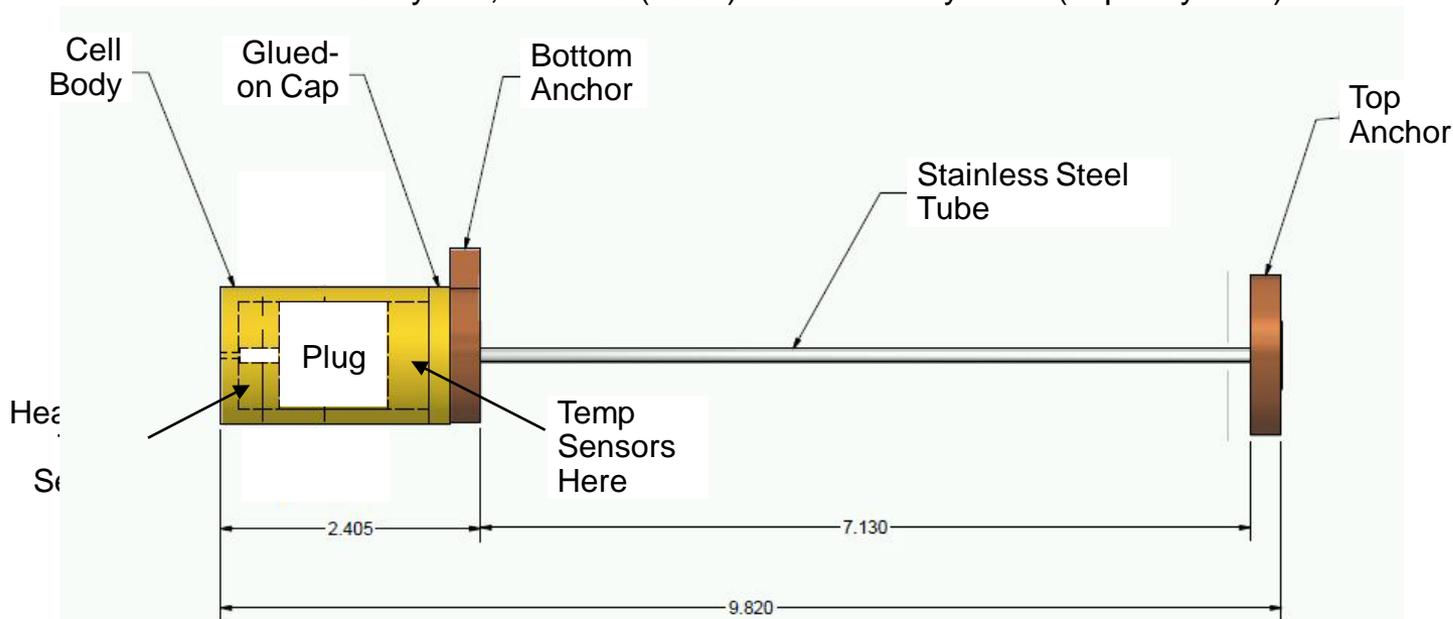


IV2 ATL

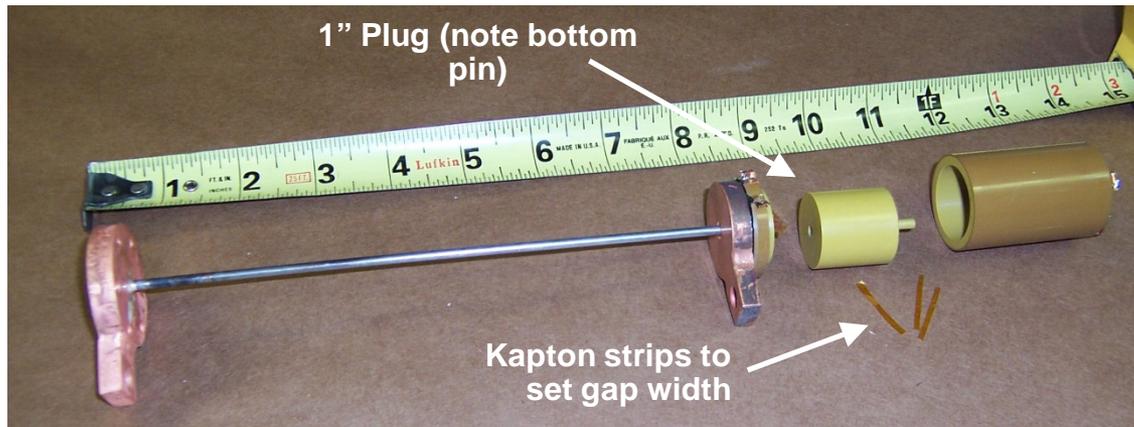
SV/evap.
purifier ATL

Thermal Conductance of an Annular Gap

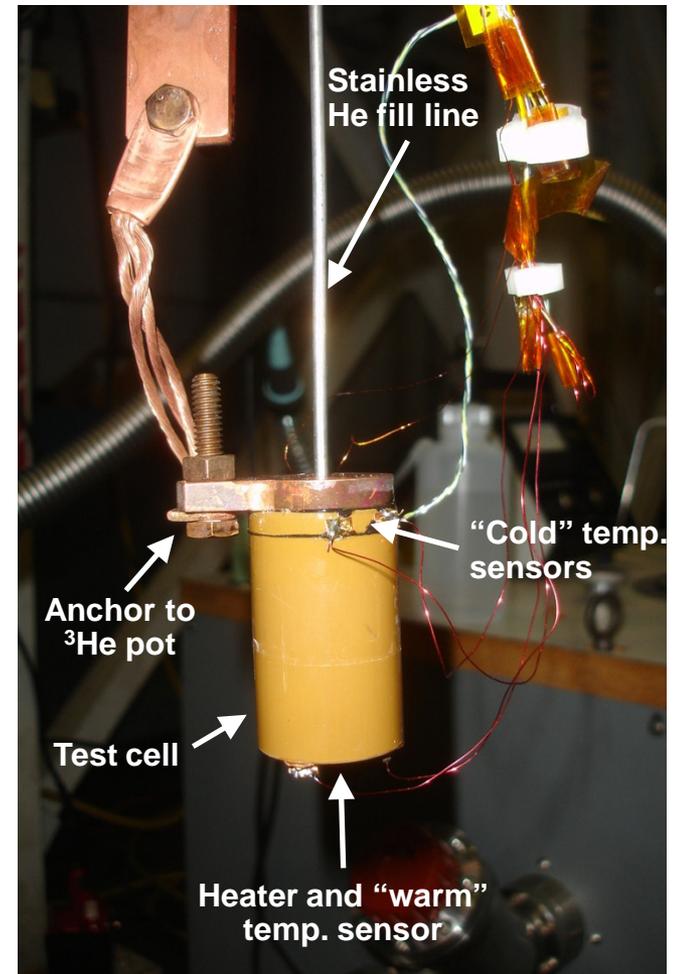
- Proof of principle: geometrically restrict phonon mean free path to reduce thermal conductance of LHe for $T < 0.6\text{K}$
- Measure for:
 - a single length (1") -- no actuation
 - a single gap width (0.001")
 - a range of temperatures ($\sim 0.4 - 0.6\text{ K}$)
- Design as simple modification to wall-depolarization apparatus
- Predict behavior following Casimir, Physica (Utrecht) **5** (1938) 495.
 - Similar to Greywall, PRB **23** (1981) 2152: for a cylinder (capillary tube)



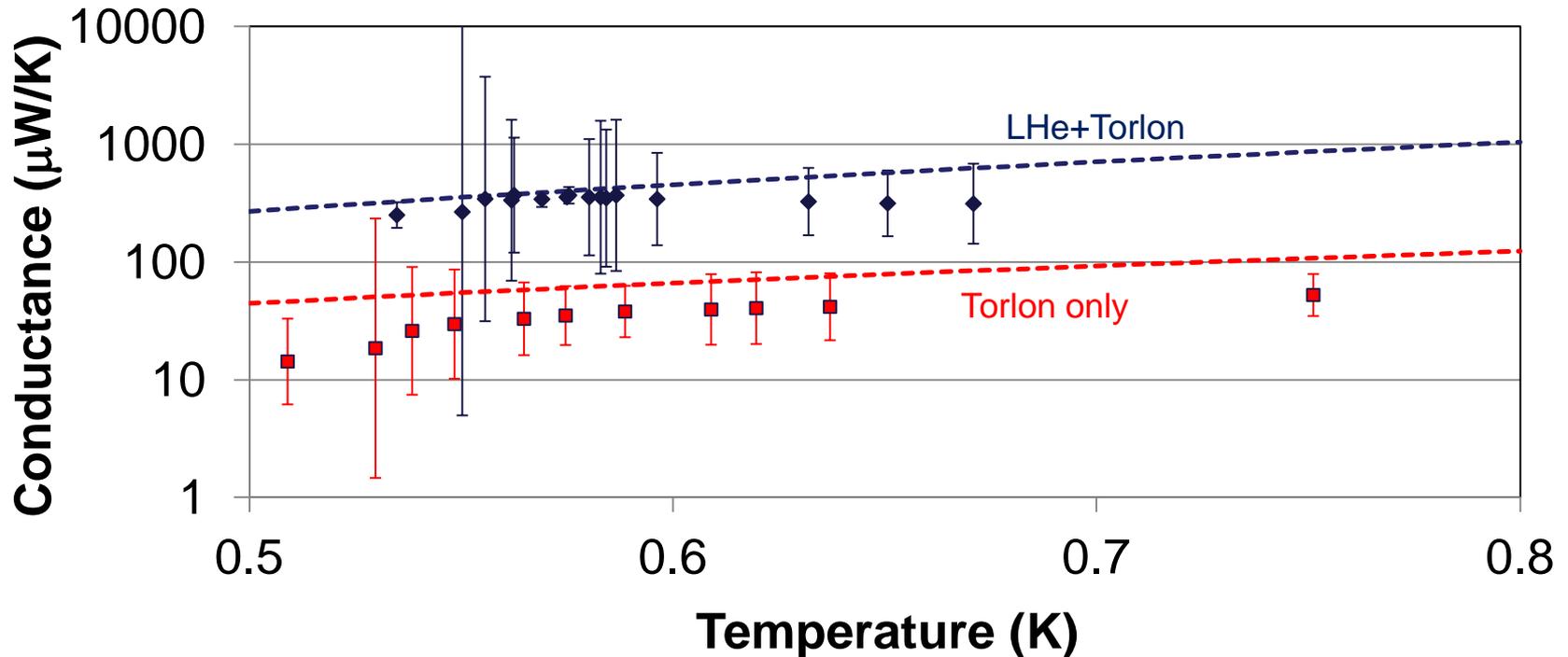
Annulus Thermal Isolation Test



Nichrome heater at bottom of cell



Annulus Thermal Conductance



- Good agreement with prediction (dotted curves)
 - Small discrepancy may be due to sensor calibration error
- Senior thesis project of Andrew (Ian) Chen (now at MIT)

^3He Wall Depolarization

- The total longitudinal relaxation time, T_1

$$\frac{1}{T_1} = \frac{1}{T_D} + \frac{1}{T_B} + \frac{1}{T_S}$$

- T_D = dipolar interaction between ^3He atoms -- not an issue at nEDM concentration
 - T_B = B-field gradient effect -- can be controlled with careful design
 - T_S = Surface (wall) effect
- For measurement cell (0.45 K, dTPB in dPS), $T_S > 1000$ s (“R&D” goal)
 - Two separate projects were launched to make the measurements at Duke/NCSU and UIUC:
 - Critical to SNS nEDM method
 - Difficult measurement
 - Involved PhD students at early stage in experiment
 - Qiang (Alan) Ye, Duke
 - Jacob Yoder, UIUC

Measuring ^3He Wall Depolarization

- The Method:
 - Cool test cell
 - UIUC: with ^3He evaporation fridge.
 - Duke/NCSU: with DR
 - Fill test cell with LHe to some level
 - Polarize ^3He at room temperature
 - UIUC: Metastability Exchange Optical Pumping
 - Duke/NCSU: Rubidium Spin-exchange Optical Pumping
 - Open isolation valve
 - ^3He to diffuses (is drawn) into LHe
 - Measure polarization vs. time with NMR
 - Repeat for other levels of LHe, concentrations of ^3He and Temperatures
- Extrapolate to geometry of nEDM



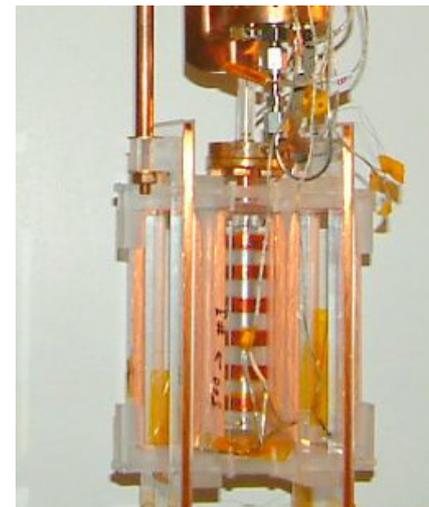
Duke/NCSU Setup



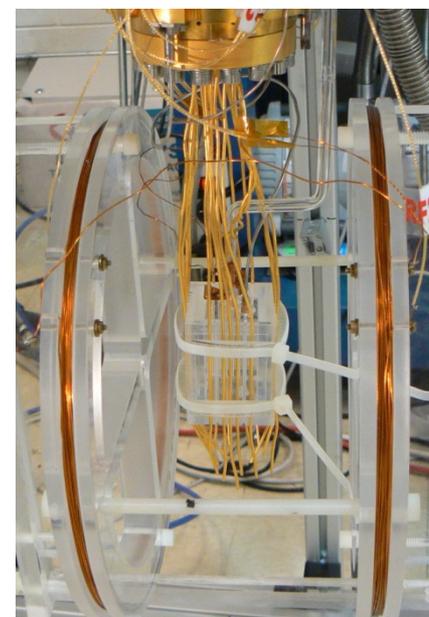
UIUC Setup

Measuring ^3He Wall Depolarization

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 - Duke/NCSU: with DR
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 - Measure polarization vs. time with NMR
 - Repeat for other levels of LHe, concentrations of ^3He and Temperatures
- Extrapolate to geometry of nEDM



Cylindrical UIUC Cell



Rectangular Duke/NCSU Cell

Extrapolation to nEDM Geometry

- If P_d is the probability per wall bounce of depolarization, can write:

$$N_{\uparrow}(t + \Delta t) = N_{\uparrow}(t) - P_d \cdot \varphi \cdot S \cdot \Delta t$$

$$\varphi = \frac{1}{4} \cdot \rho_{\uparrow}(t) \cdot \langle v \rangle = \text{flux of polarized atoms hitting unit area per unit time}$$

$$\rho_{\uparrow}(t) = \frac{N_{\uparrow}(t)}{V} = \text{density of polarized atoms}$$

$$\frac{dN_{\uparrow}}{dt} = -P_d \cdot \frac{1}{4} \cdot \langle v \rangle \cdot \frac{S}{V} \cdot N_{\uparrow}(t)$$

$$N_{\uparrow}(t) = \exp\left(\frac{-t}{T_s}\right)$$

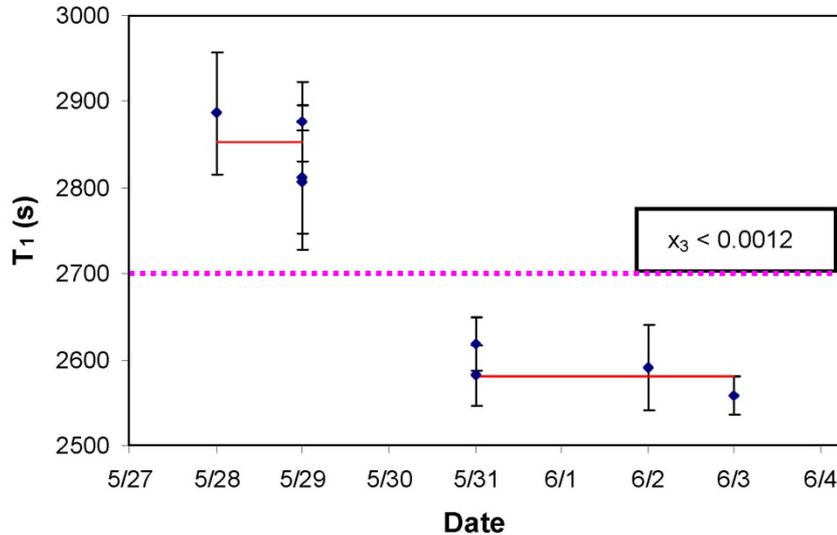
$$\frac{1}{T_s} = P_d \cdot \frac{1}{4} \cdot \langle v \rangle \cdot \frac{S}{V}$$

- Knowing P_d , can extrapolate from S/V of test cell to larger nEDM measurement cell.



^3He Relaxation Rate Data

J. Yoder Thesis

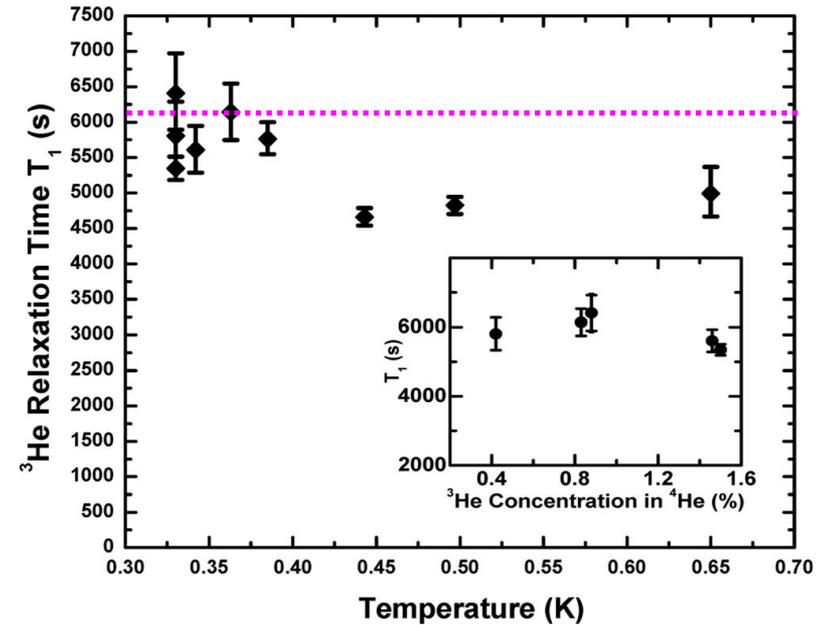


$$T_s = 2700 \pm 140 \text{ s}, S/V = 2.96 \text{ cm}^{-1}$$

$$P_d < 1.32 \times 10^{-7}$$

$$T_s^{\text{nEDM}} > 16000 \text{ s (at 0.45 K)}$$

Ye et al., Phys. Rev. A 80, 023403 (2009)



$$T_s = 6100 \text{ s}, S/V = 2.1 \text{ cm}^{-1}$$

$$P_d = 1.0 \times 10^{-7}$$

$$T_s^{\text{nEDM}} = 21,000 \text{ s (scaled to 0.45 K)}$$

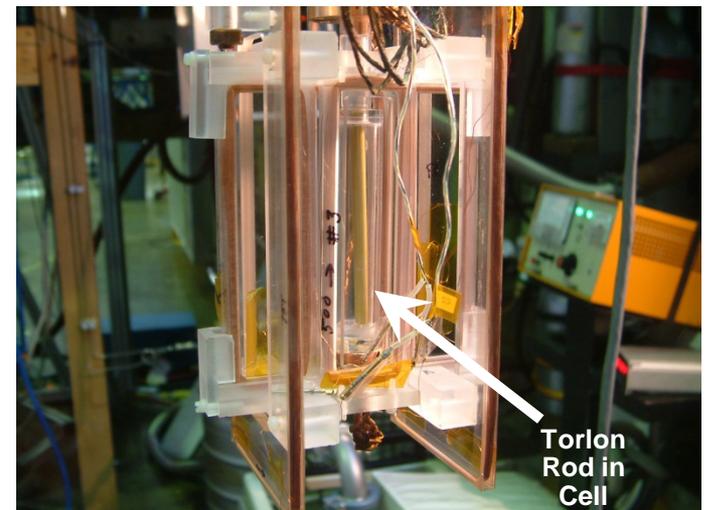
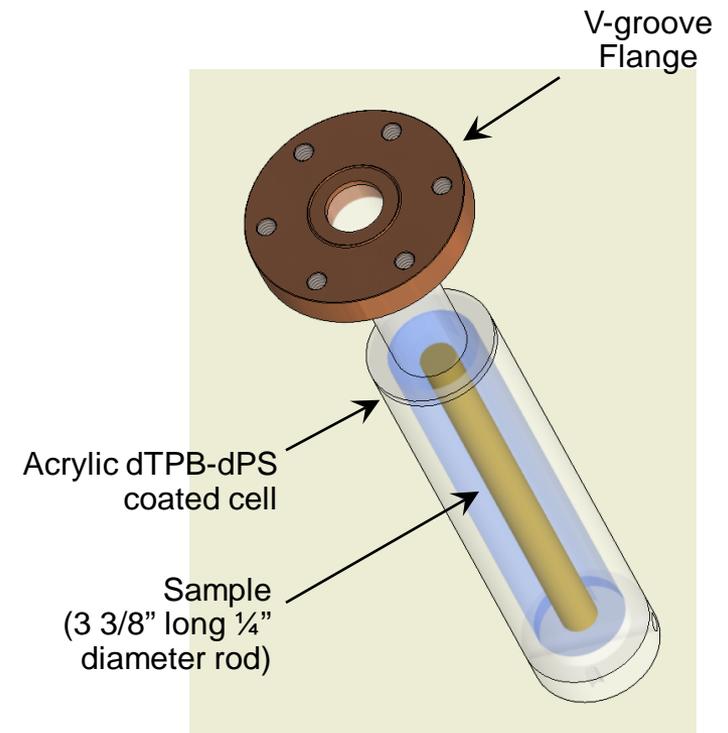
$T_s > 20,000 \text{ s}$

Other Materials

- Improved apparatus to **quickly** measure T_s on a variety of materials.
 - Use “detachable cell” with low P_d
 - Introduce sample
 - This geometry permits measurements with conductive samples (e.g. Be-Cu)
- Analysis: subtraction method
 - Measure empty cell to find $T_s^{\text{dTPB-dPS}}$
 - Measure with sample to find T_s^{Total}

$$\frac{1}{T_s^{\text{Sample}}} = \frac{1}{T_s^{\text{Total}}} - \frac{1}{T_s^{\text{dTPB-dPS}}}$$

Material	P_d
Acrylic coated with dTPB-dPS	1.0×10^{-7}
Bare Torlon 4203	$(1.01 \pm 0.08) \times 10^{-6}$
BeCu coated with Polyimide	$(7.9 \pm 0.3) \times 10^{-7}$
Torlon coated with Polyimide	$(2.5 \pm 0.1) \times 10^{-7}$

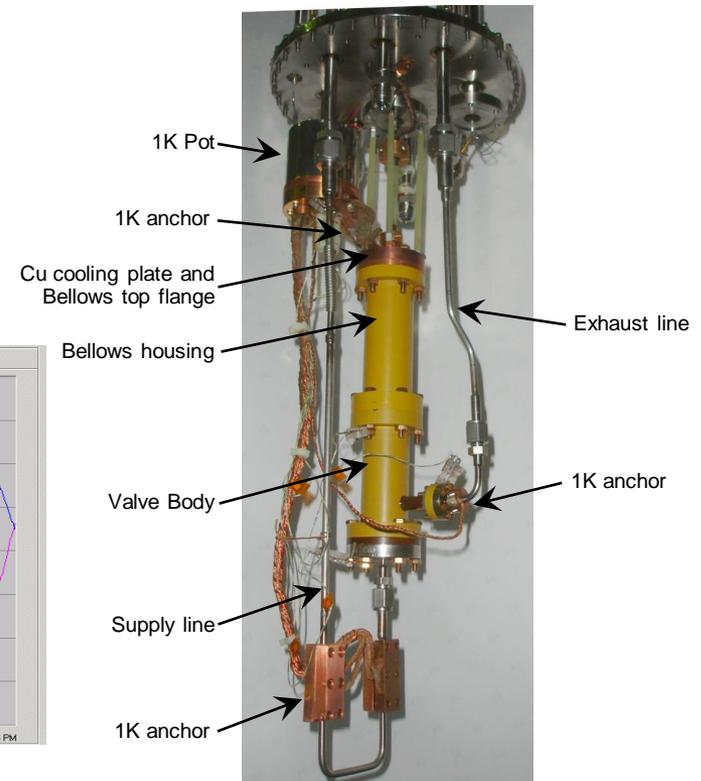
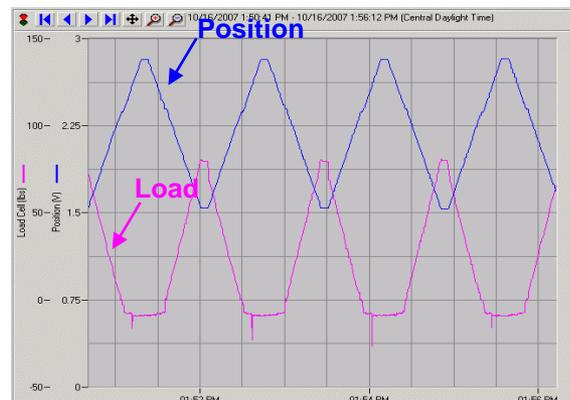
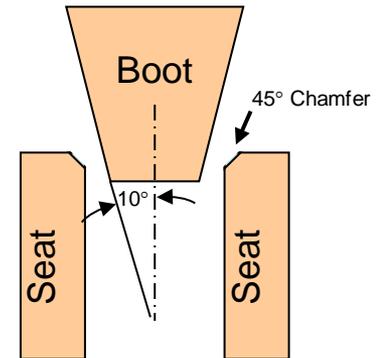


Valves

- There are lots of valves
- The valves (in the most demanding case) must be:
 - Large (1" aperture)
 - Minimal LHe open/closed volume change
 - e.g. plastic, ceramic {
 - Non-magnetic (and non-superconducting)
 - ³He friendly" (low wall depolarization probability)
 - Superfluid tight
 - Able to stand off 1 atm
 - Thermally isolating
 - Reliable (> 10,000 cycle lifetime)

Valve Development

- Demonstration of a working valve is required.
- Our solution:
 - Self-cleaning “Cork-in-bottle seal”
 - High-strength Plastics (Torlon, Vespel)
 - Polyimide-coated BeCu Bellows – hidden by another seal
 - “Australian” V-groove flange seals with Kapton gaskets
 - Low conductance annular gap for thermal isolation
- Test plan:
 - Verify seal design
 - Fabricate a full-sized prototype valve
 - Include all essential features
 - Use reasonable materials
 - Test under realistic conditions
 - LHe II inside at ~1.7 K
 - Vacuum outside
- Tested Successfully
 - 10, 000 Cycles



Valve Designs

